WINSOURCE ELECTRONICS

THE DATASHEET OF

TLE2022AIP

- **Supply Current . . . 300 μA Max**
- **High Unity-Gain Bandwidth . . . 2 MHz Typ**
- **High Slew Rate . . . 0.45 V/μs Min**
- **Supply-Current Change Over Military Temp Range . . . 10 μA Typ at $V_{CC\pm}$ = ± 15 V**
- **Specified for Both 5-V Single-Supply and ±15-V Operation**
- **Phase-Reversal Protection**
- **High Open-Loop Gain . . . 6.5 V/μV (136 dB) Typ**
- **Low Offset Voltage . . . 100 μV Max**
- **Offset Voltage Drift With Time 0.005 μV/mo Typ**
- **Low Input Bias Current . . . 50 nA Max**
- **Low Noise Voltage . . . 19 nV/$\sqrt{\text{Hz}}$ Typ**

description

The TLE202x, TLE202xA, and TLE202xB devices are precision, high-speed, low-power operational amplifiers using a new Texas Instruments Excalibur process. These devices combine the best features of the OP21 with highly improved slew rate and unity-gain bandwidth.

The complementary bipolar Excalibur process utilizes isolated vertical pnp transistors that yield dramatic improvement in unity-gain bandwidth and slew rate over similar devices.

The addition of a bias circuit in conjunction with this process results in extremely stable parameters with both time and temperature. This means that a precision device remains a precision device even with changes in temperature and over years of use.

This combination of excellent dc performance with a common-mode input voltage range that includes the negative rail makes these devices the ideal choice for low-level signal conditioning applications in either single-supply or split-supply configurations. In addition, these devices offer phase-reversal protection circuitry that eliminates an unexpected change in output states when one of the inputs goes below the negative supply rail.

A variety of available options includes small-outline and chip-carrier versions for high-density systems applications.

The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from −40°C to 85°C. The M-suffix devices are characterized for operation over the full military temperature range of −55°C to 125°C.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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TLE2021 AVAILABLE OPTIONS

T_A	V_{IO}max AT 25°C	PACKAGED DEVICES						CHIP FORM§ (Y)
		SMALL OUTLINE† (D)	SSOP‡ (DB)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	TSSOP‡ (PW)	
0°C to 70°C	200 μV 500 μV	TLE2021ACD TLE2021CD	TLE2021CDBLE	—	—	TLE2021ACP TLE2021CP	— TLE2021CPWLE	— TLE2021Y
–40°C to 85°C	200 μV 500 μV	TLE2021AID TLE2021ID	—	—	—	TLE2021AIP TLE2021IP	—	—
–55°C to 125°C	100 μV 500 μV	— TLE2021MD	—	TLE2021BMFK TLE2021MFK	TLE2021BMJG TLE2021MJG	— TLE2021MP	—	—

† The D packages are available taped and reeled. To order a taped and reeled part, add the suffix R (e.g., TLE2021CDR).
‡ The DB and PW packages are only available left-end taped and reeled.
§ Chip forms are tested at 25°C only.

TLE2022 AVAILABLE OPTIONS

T_A	V_{IO}max AT 25°C	PACKAGED DEVICES						CHIP FORM§ (Y)
		SMALL OUTLINE† (D)	SSOP‡ (DB)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	TSSOP‡ (PW)	
0°C to 70°C	150 μV 300 μV 500 μV	TLE2022BCD TLE2022ACD TLE2022CD	— — TLE2022CDBLE	—	—	— TLE2022ACP TLE2022CP	— — TLE2022CPWLE	— — TLE2022Y
–40°C to 85°C	150 μV 300 μV 500 μV	TLE2022BID TLE2022AID TLE2022ID	—	—	—	— TLE2022AIP TLE2022IP	—	—
–55°C to 125°C	150 μV 300 μV 500 μV	— TLE2022AMD TLE2022MD	—	— TLE2022AMFK TLE2022MFK	TLE2022BMJG TLE2022AMJG TLE2022MJG	— TLE2022AMP TLE2022MP	—	—

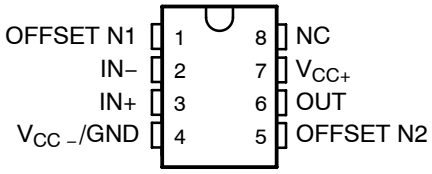
† The D packages are available taped and reeled. To order a taped and reeled part, add the suffix R (e.g., TLE2022CDR).
‡ The DB and PW packages are only available left-end taped and reeled.
§ Chip forms are tested at 25°C only.

TLE2024 AVAILABLE OPTIONS

T_A	V_{IO}max AT 25°C	PACKAGED DEVICES				CHIP FORM§ (Y)
		SMALL OUTLINE (DW)	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)	
0°C to 70°C	500 μV 750 μV 1000 μV	TLE2024BCDW TLE2024ACDW TLE2024CDW	—	—	TLE2024BCN TLE2024ACN TLE2024CN	— — TLE2024Y
–40°C to 85°C	500 μV 750 μV 1000 μV	TLE2024BIDW TLE2024AIDW TLE2024IDW	—	—	TLE2024BIN TLE2024AIN TLE2024IN	—
–55°C to 125°C	500 μV 750 μV 1000 μV	TLE2024BMDW TLE2024AMDW TLE2024MDW	TLE2024BMFK TLE2024AMFK TLE2024MFK	TLE2024BMJ TLE2024AMJ TLE2024MJ	TLE2024BMN TLE2024AMN TLE2024MN	—

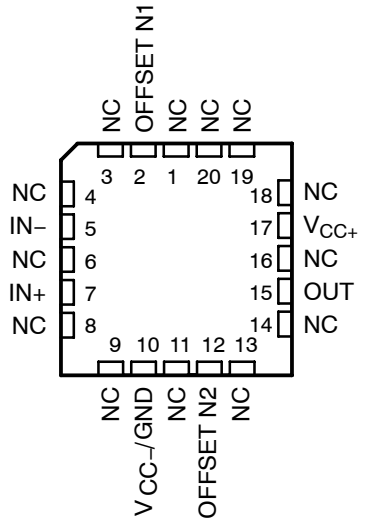
§ Chip forms are tested at 25°C only.

TLE2021
D, DB, JG, P, OR PW PACKAGE
(TOP VIEW)

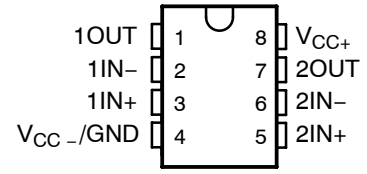


NC – No internal connection

TLE2021
FK PACKAGE
(TOP VIEW)

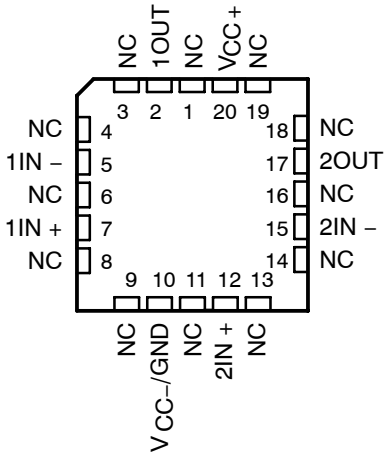


D, DB, JG, P, OR PW PACKAGE
(TOP VIEW)

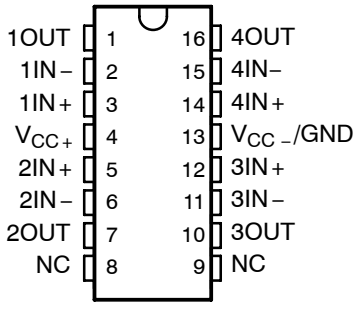


NC – No internal connection

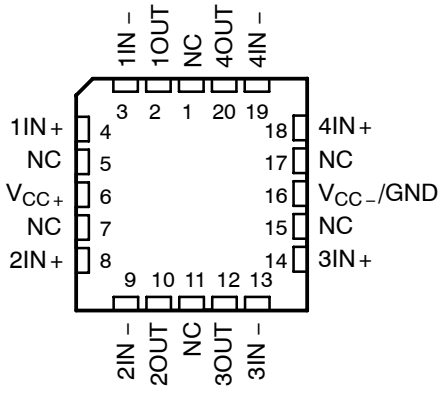
FK PACKAGE
(TOP VIEW)



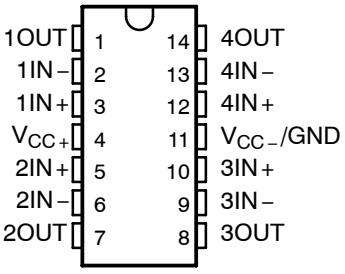
DW PACKAGE
(TOP VIEW)



FK PACKAGE
(TOP VIEW)



J OR N PACKAGE
(TOP VIEW)

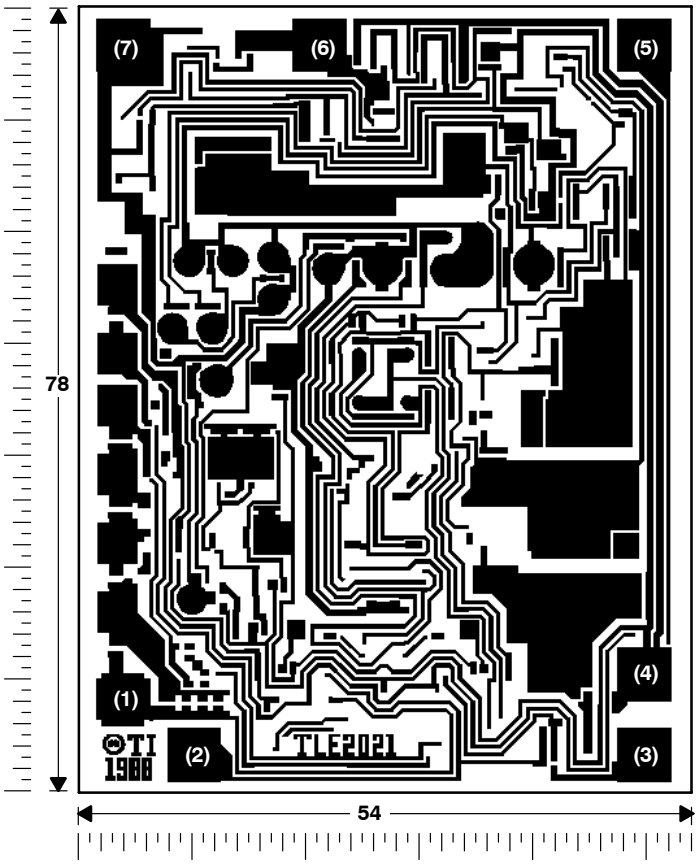


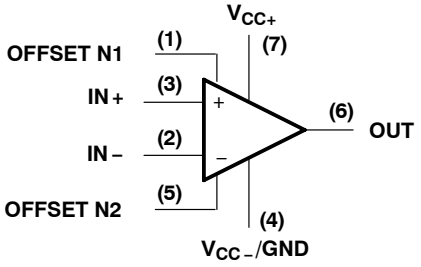
NC – No internal connection

TLE2021Y chip information

This chip, when properly assembled, display characteristics similar to the TLE2021. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. This chip may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 × 4 MILS MINIMUM

T_{Jmax}= 150°C

TOLERANCES ARE ±10%.

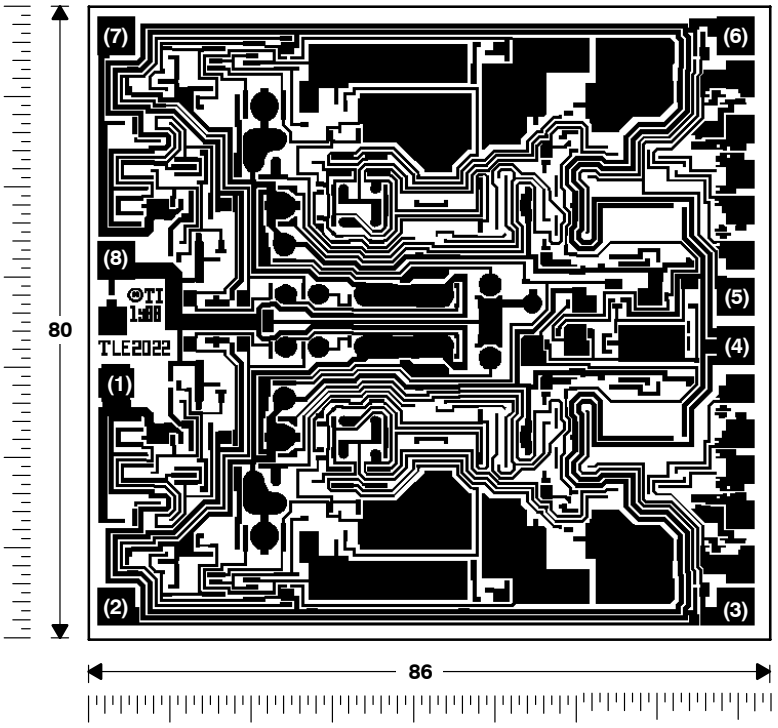
ALL DIMENSIONS ARE IN MILS.

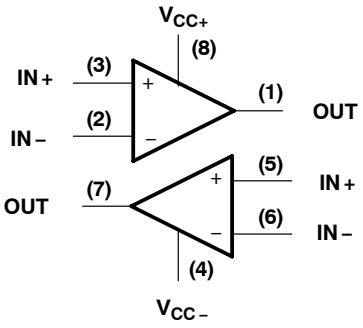
PIN (4) IS INTERNALLY CONNECTED TO BACKSIDE OF CHIP.

TLE2022Y chip information

This chip, when properly assembled, displays characteristics similar to TLE2022. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. This chip may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 × 4 MILS MINIMUM

$T_J$max = 150°C

TOLERANCES ARE ±10%.

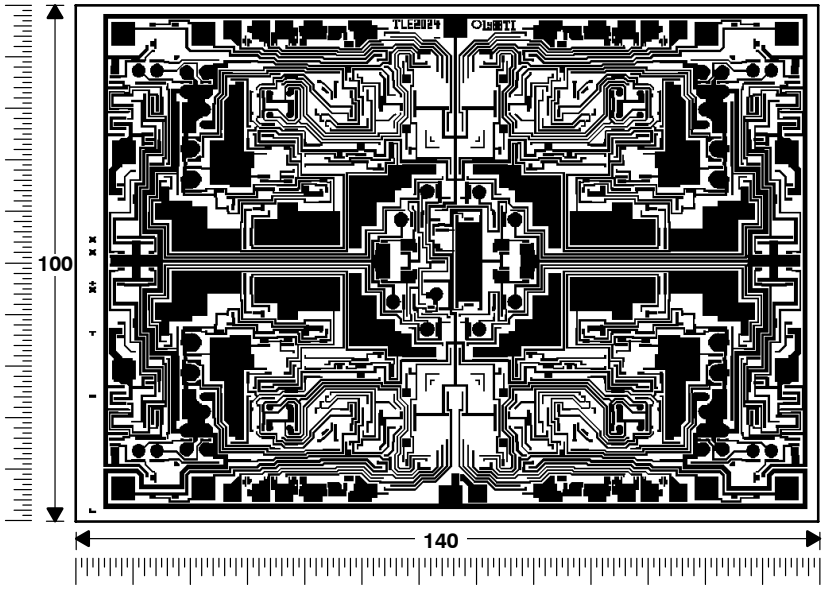
ALL DIMENSIONS ARE IN MILS.

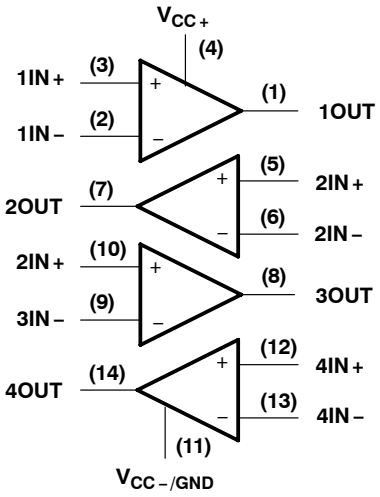
PIN (4) IS INTERNALLY CONNECTED TO BACKSIDE OF CHIP.

TLE2024Y chip information

This chip, when properly assembled, displays characteristics similar to the TLE2024. Thermal compression or ultrasonic bonding may be used on the doped aluminum-bonding pads. This chip may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 × 4 MILS MINIMUM

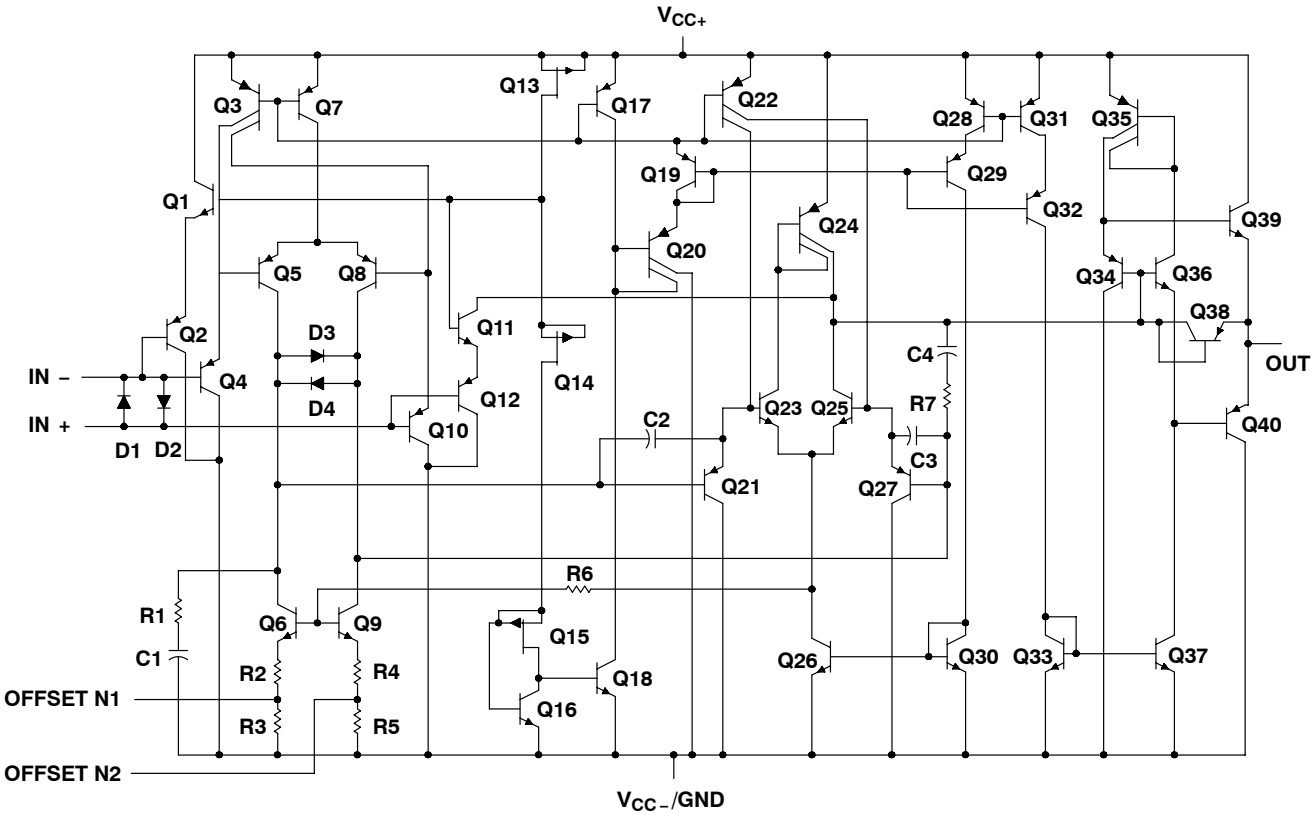
$T_J$max = 150°C

TOLERANCES ARE ±10%.

ALL DIMENSIONS ARE IN MILS.

PIN (11) IS INTERNALLY CONNECTED TO BACKSIDE OF CHIP.

equivalent schematic (each amplifier)



ACTUAL DEVICE COMPONENT COUNT			
COMPONENT	TLE2021	TLE2022	TLE2024
Transistors	40	80	160
Resistors	7	14	28
Diodes	4	8	16
Capacitors	4	8	16

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC+} (see Note 1) . . . . . 20 V
Supply voltage, V_{CC-} (see Note 1) . . . . . −20 V
Differential input voltage, V_{ID} (see Note 2) . . . . . ±0.6 V
Input voltage range, V_I (any input, see Note 1) . . . . . $\pm V_{CC}$
Input current, I_I (each input) . . . . . ±1 mA
Output current, I_O (each output): TLE2021 . . . . . ±20 mA
TLE2022 . . . . . ±30 mA
TLE2024 . . . . . ±40 mA
Total current into V_{CC+} . . . . . 80 mA
Total current out of V_{CC-} . . . . . 80 mA
Duration of short-circuit current at (or below) 25°C (see Note 3) . . . . . unlimited
Continuous total power dissipation . . . . . See Dissipation Rating Table
Operating free-air temperature range, T_A: C suffix . . . . . 0°C to 70°C
I suffix . . . . . −40°C to 85°C
M suffix . . . . . −55°C to 125°C
Storage temperature range, T_{stg} . . . . . −65°C to 150°C
Case temperature for 60 seconds, T_C: FK package . . . . . 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, DP, P, or PW package . . . . . 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package . . . . . 300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+}, and V_{CC-}.
2. Differential voltages are at IN+ with respect to IN−. Excessive current flows if a differential input voltage in excess of approximately ±600 mV is applied between the inputs unless some limiting resistance is used.
3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25°C$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25°C$	$T_A = 70°C$ POWER RATING	$T_A = 85°C$ POWER RATING	$T_A = 125°C$ POWER RATING
D–8	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
DB–8	525 mW	4.2 mW/°C	336 mW	—	—
DW–16	1025 mW	8.2 mW/°C	656 mW	533 mW	205 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J–14	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG–8	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
N–14	1150 mW	9.2 mW/°C	736 mW	598 mW	230 mW
P–8	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW
PW–8	525 mW	4.2 mW/°C	336 mW	—	—

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUFFIX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, V_{CC}		±2	±20	±2	±20	±2	±20	V
Common-mode input voltage, V_{IC}	$V_{CC} = \pm$ 5 V	0	3.5	0	3.2	0	3.2	V
	$V_{CC\pm} = \pm$15 V	−15	13.5	−15	13.2	−15	13.2	
Operating free-air temperature, T_A		0	70	−40	85	−55	125	°C

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2021C			TLE2021AC			TLE2021BC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		120	600		100	300		80	200	µV
			Full range			850			600			300	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current		25°C		0.2	6		0.2	6		0.2	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		25	70		25	70		25	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	0 to 3.5	– 0.3 to 4		0 to 3.5	– 0.3 to 4		0 to 3.5	– 0.3 to 4		V
			Full range	0 to 3.5			0 to 3.5			0 to 3.5			
V_{OH}	High-level output voltage	R_L = 10 kΩ	25°C	4	4.3		4	4.3		4	4.3		V
			Full range	3.9			3.9			3.9			
V_{OL}	Low-level output voltage		25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
			Full range			0.85			0.85			0.85	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V, R_L = 10 kΩ	25°C	0.3	1.5		0.3	1.5		0.3	1.5		V/µV
			Full range	0.3			0.3			0.3			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	85	110		85	110		85	110		dB
			Full range	80			80			80			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V	25°C	105	120		105	120		105	120		dB
			Full range	100			100			100			
I_{CC}	Supply current	V_O = 2.5 V, No load	25°C		200	300		200	300		200	300	µA
			Full range			300			300			300	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		5			5			5		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2021C			TLE2021AC			TLE2021BC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		120	500		80	200		40	100	µV
			Full range			750			500			200	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.2	6		0.2	6		0.2	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		25	70		25	70		25	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.5			−15 to 13.5			−15 to 13.5			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	14	14.3		14	14.3		14	14.3		V
			Full range	13.9			13.9			13.9			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.7			−13.7			−13.7			
A_{VD}	Large-signal differential voltage amplification	V_O = ± 10 V, R_L = 10 kΩ	25°C	1	6.5		1	6.5		1	6.5		V/µV
			Full range	1			1			1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR} min, R_S = 50 Ω	25°C	100	115		100	115		100	115		dB
			Full range	96			96			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	$V_{CC\pm}$ = ± 2.5 V to ± 15 V	25°C	105	120		105	120		105	120		dB
			Full range	100			100			100			
I_{CC}	Supply current	V_O = 0, No load	25°C		240	350		240	350		240	350	µA
			Full range			350			350			350	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		6			6			6		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2022C			TLE2022AC			TLE2022BC			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			600			400			250	µV
				Full range			800			550			400	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current			25°C		0.5	6		0.4	6		0.3	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		35	70		33	70		30	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.5			0 to 3.5			0 to 3.5			
V_{OH}	High-level output voltage	R_L = 10 kΩ		25°C	4	4.3		4	4.3		4	4.3		V
				Full range	3.9			3.9			3.9			
V_{OL}	Low-level output voltage			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.85			0.85			0.85	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.3	1.5		0.4	1.5		0.5	1.5		V/µV
				Full range	0.3			0.4			0.5			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	85	100		87	102		90	105		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V		25°C	100	115		103	118		105	120		dB
				Full range	95			98			100			
I_{CC}	Supply current	V_O = 2.5 V,	No load	25°C		450	600		450	600		450	600	µA
				Full range			600			600			600	
ΔI_{CC}	Supply current change over operating temperature range			Full range		7			7			7		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2022C			TLE2022AC			TLE2022BC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		150	500		120	300		70	150	µV
			Full range			700			450			300	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.5	6		0.4	6		0.3	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		35	70		33	70		30	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.5			−15 to 13.5			−15 to 13.5			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	14	14.3		14	14.3		14	14.3		V
			Full range	13.9			13.9			13.9			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.7			−13.7			−13.7			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V, R_L = 10 kΩ	25°C	0.8	4		1	7		1.5	10		V/µV
			Full range	0.8			1			1.5			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	95	106		97	109		100	112		dB
			Full range	91			93			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V	25°C	100	115		103	118		105	120		dB
			Full range	95			98			100			
I_{CC}	Supply current	V_O = 0, No load	25°C		550	700		550	700		550	700	µA
			Full range			700			700			700	
ΔI_{CC}	Supply current change over operating temperature range		Full range		9			9			9		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2024C			TLE2024AC			TLE2024BC			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			1100			850			600	µV
				Full range			1300			1050			800	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current			25°C		0.6	6		0.5	6		0.4	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		45	70		40	70		35	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.5			0 to 3.5			0 to 3.5			
V_{OH}	High-level output voltage	R_L = 10 kΩ		25°C	3.9	4.2		3.9	4.2		4	4.3		V
				Full range	3.7			3.7			3.8			
V_{OL}	Low-level output voltage			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.95			0.95			0.95	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.2	1.5		0.3	1.5		0.4	1.5		V/µV
				Full range	0.1			0.1			0.1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	80	90		82	92		85	95		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V		25°C	98	112		100	115		103	117		dB
				Full range	93			95			98			
I_{CC}	Supply current	V_O = 2.5 V,	No load	25°C		800	1200		800	1200		800	1200	µA
				Full range			1200			1200			1200	
ΔI_{CC}	Supply current change over operating temperature range			Full range		15			15			15		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2024C			TLE2024AC			TLE2024BC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C			1000			750			500	µV
			Full range			1200			950			700	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.6	6		0.5	6		0.4	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		50	70		45	70		40	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.5			−15 to 13.5			−15 to 13.5			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	13.8	14.1		13.9	14.2		14	14.3		V
			Full range	13.7			13.8			13.9			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.6			−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V, R_L = 10 kΩ	25°C	0.4	2		0.8	4		1	7		V/µV
			Full range	0.4			0.8			1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	92	102		94	105		97	108		dB
			Full range	88			90			93			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V	25°C	98	112		100	115		103	117		dB
			Full range	93			95			98			
I_{CC}	Supply current	V_O = 0, No load	25°C		1050	1400		1050	1400		1050	1400	µA
			Full range			1400			1400			1400	
ΔI_{CC}	Supply current change over operating temperature range		Full range		20			20			20		µA

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2021I			TLE2021AI			TLE2021BI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		120	600		100	300		80	200	µV
			Full range			950			600			300	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current		25°C		0.2	6		0.2	6		0.2	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		25	70		25	70		25	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
			Full range	0 to 3.2			0 to 3.2			0 to 3.2			
V_{OH}	High-level output voltage	R_L = 10 kΩ	25°C	4	4.3		4	4.3		4	4.3		V
			Full range	3.9			3.9			3.9			
V_{OL}	Low-level output voltage		25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
			Full range			0.9			0.9			0.9	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V, R_L = 10 kΩ	25°C	0.3	1.5		0.3	1.5		0.3	1.5		V/µV
			Full range	0.25			0.25			0.25			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR} min, R_S = 50 Ω	25°C	85	110		85	110		85	110		dB
			Full range	80			80			80			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V	25°C	105	120		105	120		105	120		dB
			Full range	100			100			100			
I_{CC}	Supply current	V_O = 2.5 V, No load	25°C		200	300		200	300		200	300	µA
			Full range			300			300			300	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		6			6			6		µA

† Full range is − 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = ± 15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2021I			TLE2021AI			TLE2021BI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		120	500		80	200		40	100	µV
			Full range			850			500			200	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.2	6		0.2	6		0.2	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		25	70		25	70		25	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.2			−15 to 13.2			−15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	14	14.3		14	14.3		14	14.3		V
			Full range	13.9			13.9			13.9			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.6			−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = 10 V, R_L = 10 kΩ	25°C	1	6.5		1	6.5		1	6.5		V/µV
			Full range	0.75			0.75			0.75			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR} min, R_S = 50 Ω	25°C	100	115		100	115		100	115		dB
			Full range	96			96			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	$V_{CC\pm}$ = ± 2. 5 V to ± 15 V	25°C	105	120		105	120		105	120		dB
			Full range	100			100			100			
I_{CC}	Supply current	V_O = 0 V, No load	25°C		240	350		240	350		240	350	µA
			Full range			350			350			350	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		7			7			7		µA

† Full range is − 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2022I			TLE2022AI			TLE2022BI			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			600			400			250	µV
				Full range			800			550			400	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current			25°C		0.5	6		0.4	6		0.3	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		35	70		33	70		30	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.2			0 to 3.2			0 to 3.2			
V_{OH}	High-level output voltage	R_L = 10 kΩ		25°C	4	4.3		4	4.3		4	4.3		V
				Full range	3.9			3.9			3.9			
V_{OL}	Low-level output voltage			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.9			0.9			0.9	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.3	1.5		0.4	1.5		0.5	1.5		V/µV
				Full range	0.2			0.2			0.2			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	85	100		87	102		90	105		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V		25°C	100	115		103	118		105	120		dB
				Full range	95			98			100			
I_{CC}	Supply current	V_O = 2.5 V,	No load	25°C		450	600		450	600		450	600	µA
				Full range			600			600			600	
ΔI_{CC}	Supply current change over operating temperature range			Full range		15			15			15		µA

† Full range is −40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = ± 15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2022I			TLE2022AI			TLE2022BI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C		150	500		120	300		70	150	µV
			Full range			700			450			300	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.5	6		0.4	6		0.3	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		35	70		33	70		30	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	– 15 to 13.5	– 15.3 to 14		– 15 to 13.5	– 15.3 to 14		– 15 to 13.5	– 15.3 to 14		V
			Full range	– 15 to 13.2			– 15 to 13.2			– 15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	14	14.3		14	14.3		14	14.3		V
			Full range	13.9			13.9			13.9			
V_{OM-}	Maximum negative peak output voltage swing		25°C	– 13.7	– 14.1		– 13.7	– 14.1		– 13.7	– 14.1		V
			Full range	– 13.6			– 13.6			– 13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ± 10 V, R_L = 10 kΩ	25°C	0.8	4		1	7		1.5	10		V/µV
			Full range	0.8			1			1.5			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	95	106		97	109		100	112		dB
			Full range	91			93			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = ±2.5 V to ±15 V	25°C	100	115		103	118		105	120		dB
			Full range	95			98			100			
I_{CC}	Supply current	V_O = 0, No load	25°C		550	700		550	700		550	700	µA
			Full range			700			700			700	
ΔI_{CC}	Supply current change over operating temperature range		Full range		30			30			30		µA

† Full range is – 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2024I			TLE2024AI			TLE2024BI			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			1100			850			600	µV
				Full range			1300			1050			800	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current			25°C		0.6	6		0.5	6		0.4	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		45	70		40	70		35	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.2			0 to 3.2			0 to 3.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		25°C	3.9	4.2		3.9	4.2		4	4.3		V
				Full range	3.7			3.7			3.8			
V_{OM-}	Maximum negative peak output voltage swing			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.95			0.95			0.95	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.2	1.5		0.3	1.5		0.4	1.5		V/µV
				Full range	0.1			0.1			0.1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	80	90		82	92		85	95		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V		25°C	98	112		100	115		103	117		dB
				Full range	93			95			98			
I_{CC}	Supply current	V_O = 0,	No load	25°C		800	1200		800	1200		800	1200	µA
				Full range			1200			1200			1200	
ΔI_{CC}	Supply current change over operating temperature range			Full range		30			30			30		µA

† Full range is −40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2024I			TLE2024AI			TLE2024BI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C			1000			750			500	µV
			Full range			1200			950			700	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.6	6		0.5	6		0.4	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		50	70		45	70		40	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.2			−15 to 13.2			−15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	13.8	14.1		13.9	14.2		14	14.3		V
			Full range	13.7			13.7			13.8			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.6			−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V, R_L = 10 kΩ	25°C	0.4	2		0.8	4		1	7		V/µV
			Full range	0.4			0.8			1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	92	102		94	105		97	108		dB
			Full range	88			90			93			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V	25°C	98	112		100	115		103	117		dB
			Full range	93			95			98			
I_{CC}	Supply current	V_O = 0, No load	25°C		1050	1400		1050	1400		1050	1400	µA
			Full range			1400			1400			1400	
ΔI_{CC}	Supply current change over operating temperature range		Full range		50			50			50		µA

† Full range is −40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2021M			TLE2021BM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C		120	600		80	200	μV
				Full range			1100			300	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005		μV/mo
I_{IO}	Input offset current			25°C		0.2	6		0.2	6	nA
				Full range			10			10	
I_{IB}	Input bias current			25°C		25	70		25	70	nA
				Full range			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.2			0 to 3.2			
V_{OH}	High-level output voltage	R_L = 10 kΩ		25°C	4	4.3		4	4.3		V
				Full range	3.8			3.8			
V_{OL}	Low-level output voltage			25°C		0.7	0.8		0.7	0.8	V
				Full range			0.95			0.95	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.3	1.5		0.3	1.5		V/μV
				Full range	0.1			0.1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	85	110		85	110		dB
				Full range	80			80			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V		25°C	105	120		105	120		dB
				Full range	100			100			
I_{CC}	Supply current	V_O = 2.5 V,	No load	25°C		170	230		170	230	μA
				Full range			230			230	
ΔI_{CC}	Supply current change over operating temperature range			Full range		9			9		μA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2021M			TLE2021BM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C		120	500		40	100	µV
				Full range			1000			200	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.006			0.006		µV/mo
I_{IO}	Input offset current			25°C		0.2	6		0.2	6	nA
				Full range			10			10	
I_{IB}	Input bias current			25°C		25	70		25	70	nA
				Full range			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
				Full range	−15 to 13.2			−15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		25°C	14	14.3		14	14.3		V
				Full range	13.8			13.8			
V_{OM-}	Maximum negative peak output voltage swing			25°C	−13.7	−14.1		−13.7	−14.1		V
				Full range	−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V,	R_L = 10 kΩ	25°C	1	6.5		1	6.5		V/µV
				Full range	0.5			0.5			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	100	115		100	115		dB
				Full range	96			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ± 2.5 V to ±15 V		25°C	105	120		105	120		dB
				Full range	100			100			
I_{CC}	Supply current	V_O = 0,	No load	25°C		200	300		200	300	µA
				Full range			300			300	
ΔI_{CC}	Supply current change over operating temperature range			Full range		10			10		µA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2022M			TLE2022AM			TLE2022BM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			600			400			250	μV
				Full range			800			550			400	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		μV/mo
I_{IO}	Input offset current			25°C		0.5	6		0.4	6		0.3	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		35	70		33	70		30	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.2			0 to 3.2			0 to 3.2			
V_{OH}	High-level output voltage	R_L = 10 kΩ		25°C	4	4.3		4	4.3		4	4.3		V
				Full range	3.8			3.8			3.8			
V_{OL}	Low-level output voltage			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.95			0.95			0.95	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.3	1.5		0.4	1.5		0.5	1.5		V/μV
				Full range	0.1			0.1			0.1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	85	100		87	102		90	105		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V		25°C	100	115		103	118		105	120		dB
				Full range	95			98			100			
I_{CC}	Supply current	V_O = 2.5 V,	No load	25°C		450	600		450	600		450	600	μA
				Full range			600			600			600	
ΔI_{CC}	Supply current change over operating temperature range			Full range		37			37			37		μA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2022M			TLE2022AM			TLE2022BM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C		150	500		120	300		70	150	µV
				Full range			700			450			300	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current			25°C		0.5	6		0.4	6		0.3	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		35	70		33	70		30	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
				Full range	−15 to 13.2			−15 to 13.2			−15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		25°C	14	14.3		14	14.3		14	14.3		V
				Full range	13.9			13.9			13.9			
V_{OM-}	Maximum negative peak output voltage swing			25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
				Full range	−13.6			−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V,	R_L = 10 kΩ	25°C	0.8	4		1	7		1.5	10		V/µV
				Full range	0.8			1			1.5			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	95	106		97	109		100	112		dB
				Full range	91			93			96			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V		25°C	100	115		103	118		105	120		dB
				Full range	95			98			100			
I_{CC}	Supply current	V_O = 0,	No load	25°C		550	700		550	700		550	700	µA
				Full range			700			700			700	
ΔI_{CC}	Supply current change over operating temperature range			Full range		60			60			60		µA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2024M			TLE2024AM			TLE2024BM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω	25°C			1100			850			600	µV
				Full range			1300			1050			800	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.005			0.005			0.005		µV/mo
I_{IO}	Input offset current			25°C		0.6	6		0.5	6		0.4	6	nA
				Full range			10			10			10	
I_{IB}	Input bias current			25°C		45	70		40	70		35	70	nA
				Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω		25°C	0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		0 to 3.5	−0.3 to 4		V
				Full range	0 to 3.2			0 to 3.2			0 to 3.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		25°C	3.9	4.2		3.9	4.2		4	4.3		V
				Full range	3.7			3.7			3.8			
V_{OM-}	Maximum negative peak output voltage swing			25°C		0.7	0.8		0.7	0.8		0.7	0.8	V
				Full range			0.95			0.95			0.95	
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ	25°C	0.2	1.5		0.3	1.5		0.4	1.5		V/µV
				Full range	0.1			0.1			0.1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	25°C	80	90		82	92		85	95		dB
				Full range	80			82			85			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V		25°C	98	112		100	115		103	117		dB
				Full range	93			95			98			
I_{CC}	Supply current	V_O = 0,	No load	25°C		800	1200		800	1200		800	1200	µA
				Full range			1200			1200			1200	
ΔI_{CC}	Supply current change over operating temperature range			Full range		50			50			50		µA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024 electrical characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2024M			TLE2024AM			TLE2024BM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0, R_S = 50 Ω	25°C			1000			750			500	µV
			Full range			1200			950			700	
α_{VIO}	Temperature coefficient of input offset voltage		Full range		2			2			2		µV/°C
	Input offset voltage long-term drift (see Note 4)		25°C		0.006			0.006			0.006		µV/mo
I_{IO}	Input offset current		25°C		0.6	6		0.5	6		0.4	6	nA
			Full range			10			10			10	
I_{IB}	Input bias current		25°C		50	70		45	70		40	70	nA
			Full range			90			90			90	
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω	25°C	−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		−15 to 13.5	−15.3 to 14		V
			Full range	−15 to 13.2			−15 to 13.2			−15 to 13.2			
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ	25°C	13.8	14.1		13.9	14.2		14	14.3		V
			Full range	13.7			13.7			13.8			
V_{OM-}	Maximum negative peak output voltage swing		25°C	−13.7	−14.1		−13.7	−14.1		−13.7	−14.1		V
			Full range	−13.6			−13.6			−13.6			
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V, R_L = 10 kΩ	25°C	0.4	2		0.8	4		1	7		V/µV
			Full range	0.4			0.8			1			
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	92	102		94	105		97	108		dB
			Full range	88			90			93			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±2.5 V to ±15 V	25°C	98	112		100	115		103	117		dB
			Full range	93			95			98			
I_{CC}	Supply current	V_O = 0, No load	25°C		1050	1400		1050	1400		1050	1400	µA
			Full range			1400			1400			1400	
ΔI_{CC}	Supply current change over operating temperature range		Full range		85			85			85		µA

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021 operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	T_A	C SUFFIX			I SUFFIX			M SUFFIX			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V, See Figure 1	25°C		0.5			0.5			0.5		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz	25°C		21	50		21	50		21		nV/Hz
		f = 1 kHz	25°C		17	30		17	30		17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz	25°C		0.47			0.47			0.47		
I_n	Equivalent input noise current		25°C		0.09			0.09			0.9		pA/Hz
B_1	Unity-gain bandwidth	See Figure 3	25°C		1.2			1.2			1.2		MHz
ϕ_m	Phase margin at unity gain	See Figure 3	25°C		42°			42°			42°		

TLE2021 operating characteristics at specified free-air temperature, V_{CC} = ±15 V

PARAMETER		TEST CONDITIONS	T_A†	C SUFFIX			I SUFFIX			M SUFFIX			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1V to 3 V, See Figure 1	25°C	0.45	0.65		0.45	0.65		0.45	0.65		V/μs
			Full range	0.45			0.42			0.45			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz	25°C		19	50		19	50		19		nV/Hz
		f = 1 kHz	25°C		15	30		15	30		15		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz	25°C		0.47			0.47			0.47		
I_n	Equivalent input noise current		25°C		0.09			0.09			0.09		pA/Hz
B_1	Unity-gain bandwidth	See Figure 3	25°C		2			2			2		MHz
ϕ_m	Phase margin at unity gain	See Figure 3	25°C		46°			46°			46°		

† Full range is 0°C to 70°C for the C-suffix devices, –40°C to 85°C for the I-suffix devices, and –55°C to 125°C for the M-suffix devices.

TLE2022 operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	C SUFFIX			I SUFFIX			M SUFFIX			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V, See Figure 1		0.5			0.5			0.5		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz		21	50		21	50		21		nV/√Hz
		f = 1 kHz		17	30		17	30		17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz		0.47			0.47			0.47		
I_n	Equivalent input noise current			0.1			0.1			0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3		1.7			1.7			1.7		MHz
ϕ_m	Phase margin at unity gain	See Figure 3		47°			47°			47°		

TLE2022 operating characteristics at specified free-air temperature, V_{CC} = ±15 V

PARAMETER		TEST CONDITIONS	T_A	C SUFFIX†			I SUFFIX†			M SUFFIX†			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = ±10 V, See Figure 1	25°C	0.45	0.65		0.45	0.65		0.45	0.65		V/μs
			Full range	0.45			0.42			0.4			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz	25°C		19	50		19	50		19		nV/√Hz
		f = 1 kHz	25°C		15	30		15	30		15		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz	25°C		0.47			0.47			0.47		
I_n	Equivalent input noise current		25°C		0.1			0.1			0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3	25°C		2.8			2.8			2.8		MHz
ϕ_m	Phase margin at unity gain	See Figure 3	25°C		52°			52°			52°		

† Full range is 0°C to 70°C for the C–suffix devices, –40°C to 85°C for the I suffix devices and –55°C to 125°C for the I–suffix devices.

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TLE2024 operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	C SUFFIX			I SUFFIX			M SUFFIX			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V, See Figure 1		0.5			0.5			0.5		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz		21	50		21	50		21		nV/√Hz
		f = 1 kHz		17	30		17	30		17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz		0.47			0.47			0.47		
I_n	Equivalent input noise current			0.1			0.1			0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3		1.7			1.7			1.7		MHz
ϕ_m	Phase margin at unity gain	See Figure 3		47°			47°			47°		

TLE2024 operating characteristics at specified free-air temperature, V_{CC} = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A	C SUFFIX†			I SUFFIX†			M SUFFIX†			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = ±10 V, See Figure 1	25°C	0.45	0.7		0.45	0.7		0.45	0.7		V/μs
			Full range	0.45			0.42			0.4			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz	25°C		19	50		19	50		19		nV/√Hz
		f = 1 kHz	25°C		15	30		15	30		15		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz	25°C		0.16			0.16			0.16		μV
		f = 0.1 to 10 Hz	25°C		0.47			0.47			0.47		
I_n	Equivalent input noise current		25°C		0.1			0.1			0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3	25°C		2.8			2.8			2.8		MHz
ϕ_m	Phase margin at unity gain	See Figure 3	25°C		52°			52°			52°		

† Full range is 0°C to 70°C for the C–suffix devices, –40°C to 85°C for the I suffix devices and –55°C to 125°C for the I–suffix devices.

TLE2021Y electrical characteristics at V_{CC} = 5 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TLE2021Y			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω		150		μV
	Input offset voltage long-term drift (see Note 4)				0.005		μV/mo
I_{IO}	Input offset current				0.5		nA
I_{IB}	Input bias current				35		nA
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω			– 0.3 to 4		V
V_{OH}	Maximum high-level output voltage	R_L = 10 kΩ			4.3		V
V_{OL}	Maximum low-level output voltage				0.7		V
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 to 4 V,	R_L = 10 kΩ		1.5		V/μV
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR} min,	R_S = 50 Ω		100		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V			115		dB
I_{CC}	Supply current	V_O = 2.5 V,	No load		400		μA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2021Y operating characteristics at V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	TLE2021Y			UNIT
			MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V		0.5		V/μs
V_n	Equivalent input noise voltage	f = 10 Hz		21		nV/√Hz
		f = 1 kHz		17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz		0.16		μV
		f = 0.1 to 10 Hz		0.47		
I_n	Equivalent input noise current			0.1		pA/√Hz
B_1	Unity-gain bandwidth			1.7		MHz
ϕ_m	Phase margin at unity gain			47°		

TLE2022Y electrical characteristics, V_{CC} = 5 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TLE2022Y			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω		150	600	μV
	Input offset voltage long-term drift (see Note 4)				0.005		μV/mo
I_{IO}	Input offset current				0.5		nA
I_{IB}	Input bias current				35		nA
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω			– 0.3 to 4		V
V_{OH}	Maximum high-level output voltage	R_L = 10 kΩ			4.3		V
V_{OL}	Maximum low-level output voltage				0.7		V
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 to 4 V,	R_L= 10 kΩ		1.5		V/μV
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR} min,	R_S = 50 Ω		100		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V			115		dB
I_{CC}	Supply current	V_O = 2.5 V,	No load		450		μA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2022Y operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2022Y			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V,	See Figure 1		0.5		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz			21		nV/√Hz
		f = 1 kHz			17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz			0.16		μV
		f = 0.1 to 10 Hz			0.47		
I_n	Equivalent input noise current				0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3			1.7		MHz
ϕ_m	Phase margin at unity gain	See Figure 3			47°		

TLE2024Y electrical characteristics, V_{CC} = 5 V, T_A = 25°C (unless otherwise noted)

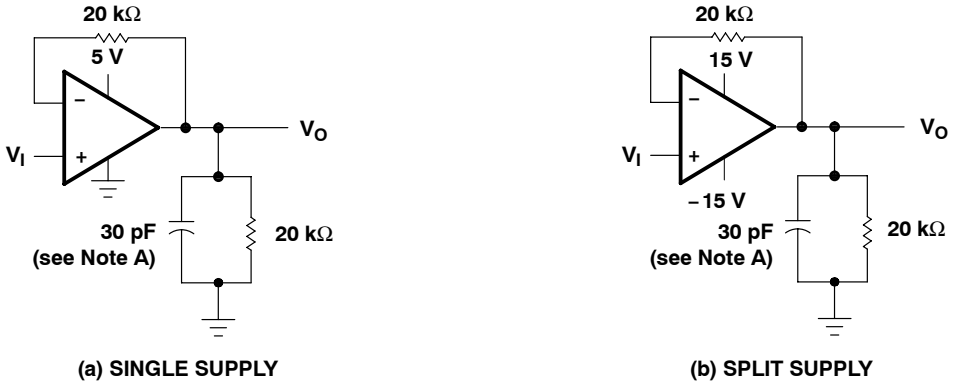
PARAMETER		TEST CONDITIONS		TLE2024Y			UNIT
				MIN	TYP	MAX	
	Input offset voltage long-term drift (see Note 4)	V_{IC} = 0,	R_S = 50 Ω		0.005		μV/mo
I_{IO}	Input offset current				0.6		nA
I_{IB}	Input bias current				45		nA
V_{ICR}	Common-mode input voltage range	R_S = 50 Ω			–0.3 to 4		V
V_{OH}	High-level output voltage	R_L = 10 kΩ			4.2		V
V_{OL}	Low-level output voltage				0.7		V
A_{VD}	Large-signal differential voltage amplification	V_O = 1.4 V to 4 V,	R_L = 10 kΩ		1.5		V/μV
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω		90		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	V_{CC} = 5 V to 30 V			112		dB
I_{CC}	Supply current	V_O = 2.5 V,	No load		800		μA

NOTE 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2024Y operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2024Y			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain	V_O = 1 V to 3 V,	See Figure 1		0.5		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz			21		nV/√Hz
		f = 1 kHz			17		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 to 1 Hz			0.16		μV
		f = 0.1 to 10 Hz			0.47		
I_n	Equivalent input noise current				0.1		pA/√Hz
B_1	Unity-gain bandwidth	See Figure 3			1.7		MHz
ϕ_m	Phase margin at unity gain	See Figure 3			47°		

PARAMETER MEASUREMENT INFORMATION

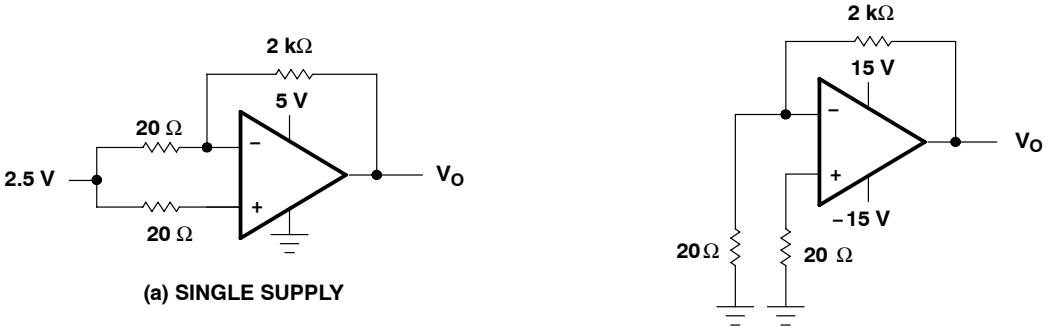


(a) SINGLE SUPPLY

(b) SPLIT SUPPLY

NOTE A: C_L includes fixture capacitance.

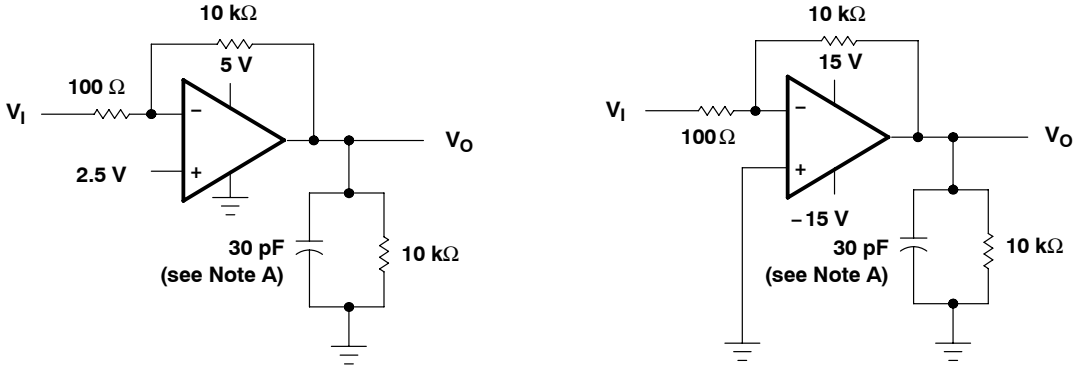
Figure 1. Slew-Rate Test Circuit



(a) SINGLE SUPPLY

(b) SPLIT SUPPLY

Figure 2. Noise-Voltage Test Circuit



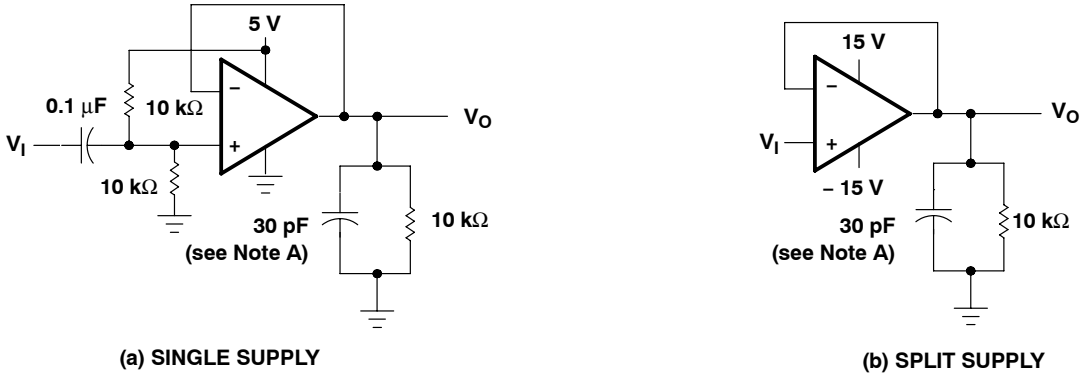
(a) SINGLE SUPPLY

(b) SPLIT SUPPLY

NOTE A: C_L includes fixture capacitance.

Figure 3. Unity-Gain Bandwidth and Phase-Margin Test Circuit

PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 4. Small-Signal Pulse-Response Test Circuit

typical values

Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
V_{IO}	Input offset voltage	Distribution	5, 6, 7
I_{IB}	Input bias current	vs Common-mode input voltage vs Free-air temperature	8, 9, 10 11, 12, 13
I_I	Input current	vs Differential input voltage	14
V_{OM}	Maximum peak output voltage	vs Output current vs Free-air temperature	15, 16, 17 18
V_{OH}	High-level output voltage	vs High-level output current vs Free-air temperature	19, 20 21
V_{OL}	Low-level output voltage	vs Low-level output current vs Free-air temperature	22 23
$V_{O(PP)}$	Maximum peak-to-peak output voltage	vs Frequency	24, 25
A_{VD}	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	26 27, 28, 29
I_{OS}	Short-circuit output current	vs Supply voltage vs Free-air temperature	30 – 33 34 – 37
I_{CC}	Supply current	vs Supply voltage vs Free-air temperature	38, 39, 40 41, 42, 43
CMRR	Common-mode rejection ratio	vs Frequency	44, 45, 46
SR	Slew rate	vs Free-air temperature	47, 48, 49
	Voltage-follower small-signal pulse response		50, 51
	Voltage-follower large-signal pulse response		52 – 57
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	0.1 to 1 Hz 0.1 to 10 Hz	58 59
V_n	Equivalent input noise voltage	vs Frequency	60
B_1	Unity-gain bandwidth	vs Supply voltage vs Free-air temperature	61, 62 63, 64
ϕ_m	Phase margin	vs Supply voltage vs Load capacitance vs Free-air temperature	65, 66 67, 68 69, 70
	Phase shift	vs Frequency	26

TYPICAL CHARACTERISTICS

**DISTRIBUTION OF TLE2021
INPUT OFFSET VOLTAGE**

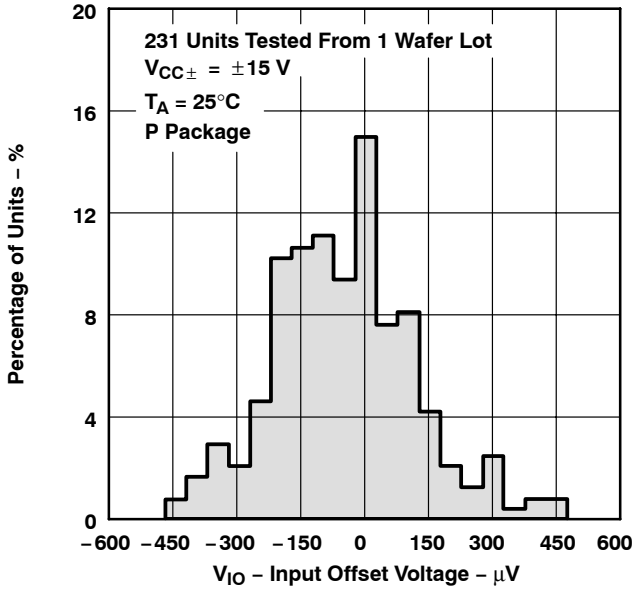


Figure 5

**DISTRIBUTION OF TLE2022
INPUT OFFSET VOLTAGE**

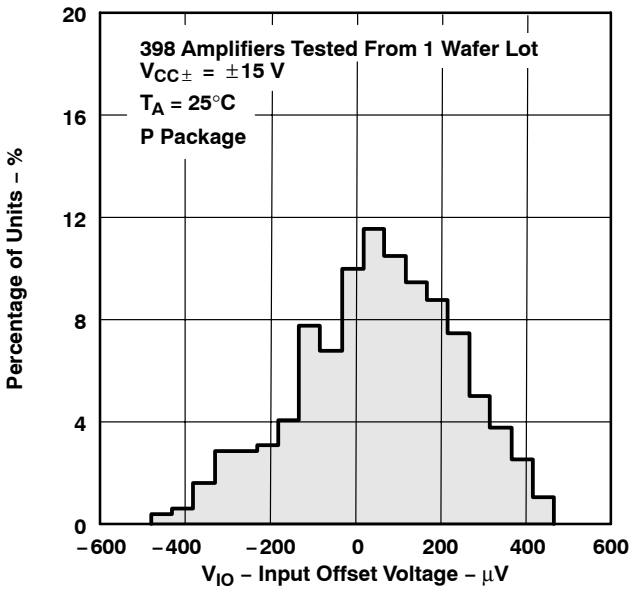


Figure 6

**DISTRIBUTION OF TLE2024
INPUT OFFSET VOLTAGE**

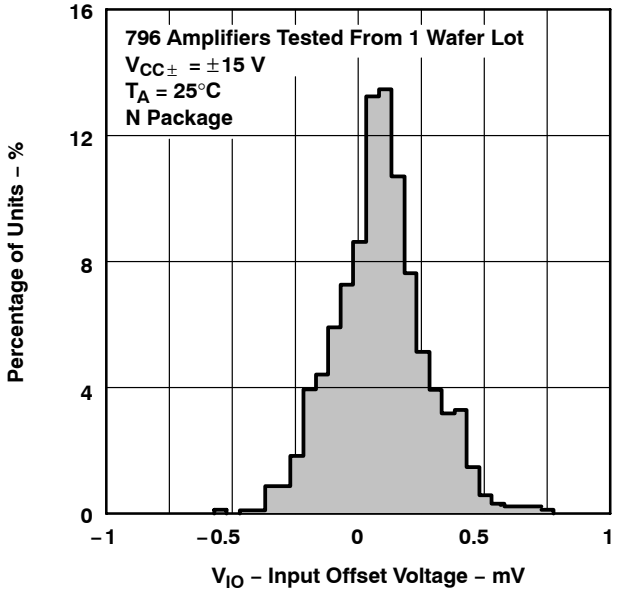


Figure 7

**TLE2021
INPUT BIAS CURRENT
vs
COMMON-MODE INPUT VOLTAGE**

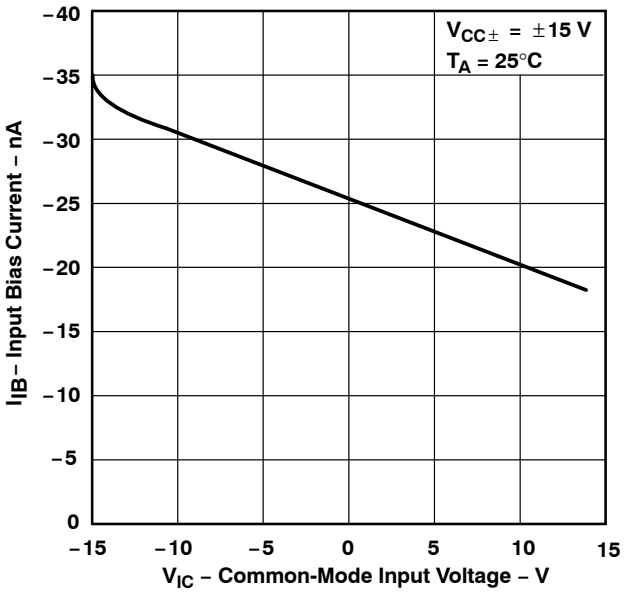


Figure 8

TYPICAL CHARACTERISTICS

TLE2022
INPUT BIAS CURRENT
vs
COMMON-MODE INPUT VOLTAGE

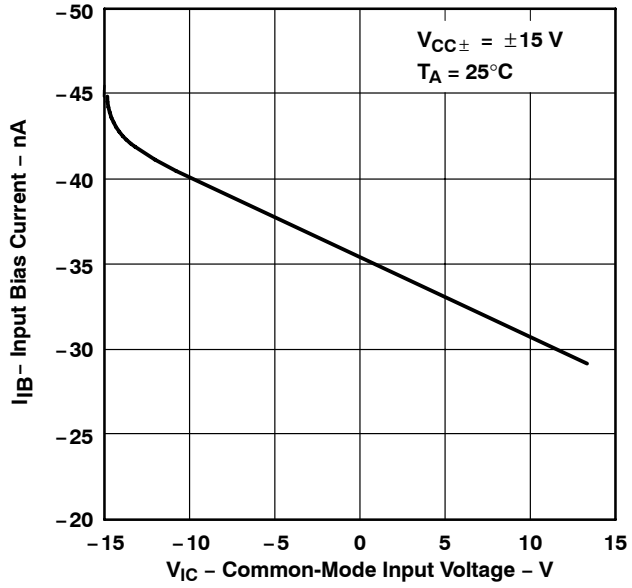


Figure 9

TLE2024
INPUT BIAS CURRENT
vs
COMMON-MODE INPUT VOLTAGE

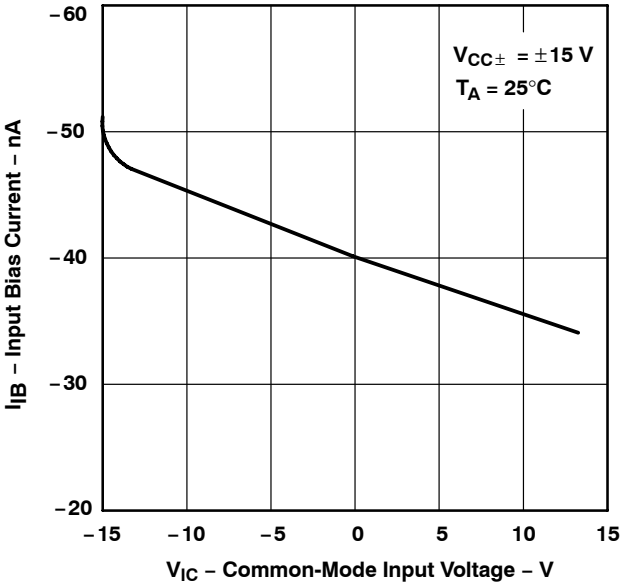


Figure 10

TLE2021
INPUT BIAS CURRENT†
vs
FREE-AIR TEMPERATURE

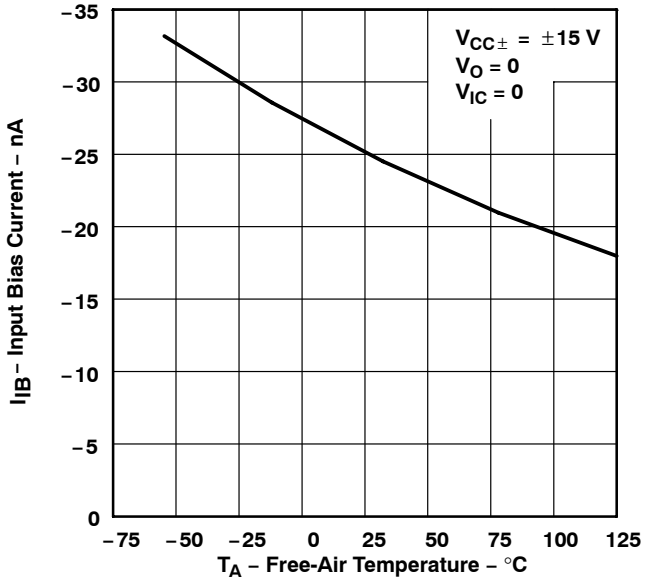


Figure 11

TLE2022
INPUT BIAS CURRENT†
vs
FREE-AIR TEMPERATURE

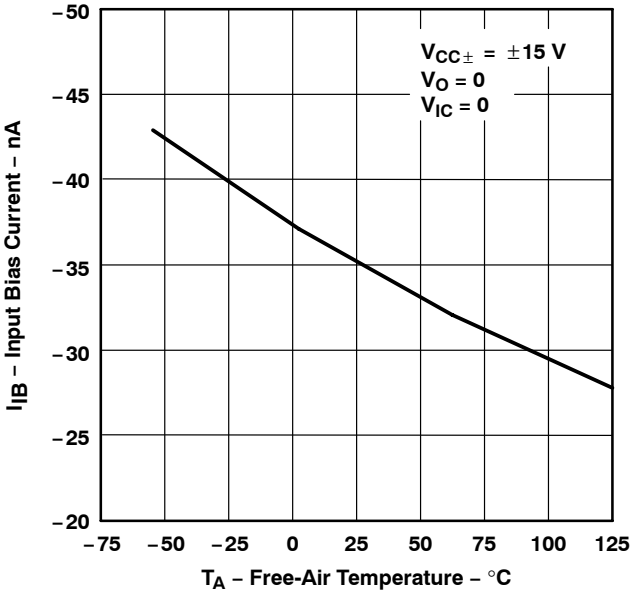


Figure 12

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2024
INPUT BIAS CURRENT†
vs
FREE-AIR TEMPERATURE

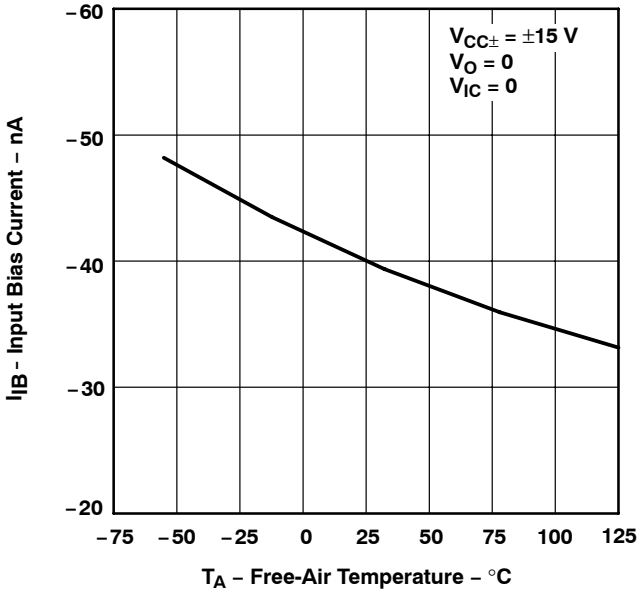


Figure 13

INPUT CURRENT
vs
DIFFERENTIAL INPUT VOLTAGE

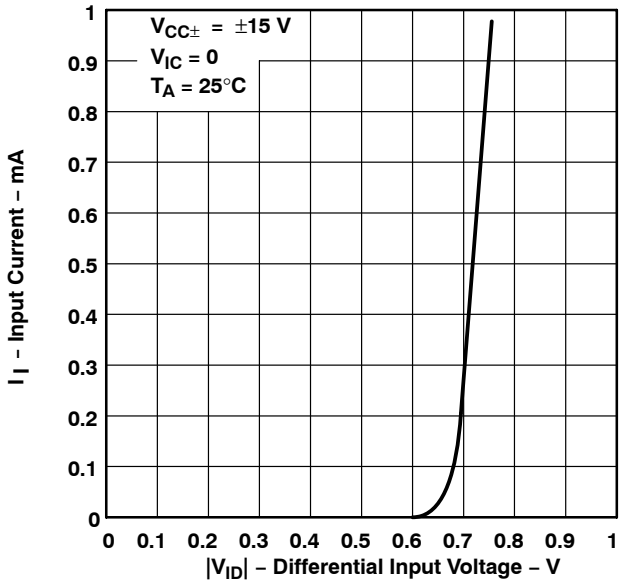


Figure 14

TLE2021
MAXIMUM PEAK OUTPUT VOLTAGE
vs
OUTPUT CURRENT

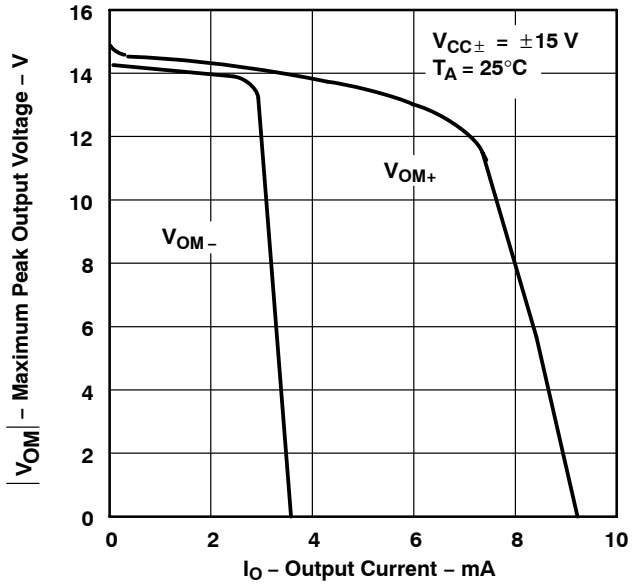


Figure 15

TLE2022
MAXIMUM PEAK OUTPUT VOLTAGE
vs
OUTPUT CURRENT

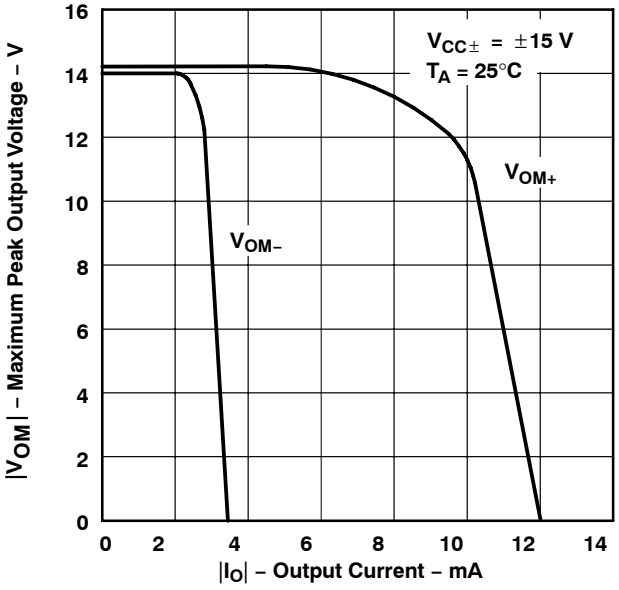


Figure 16

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2024
MAXIMUM PEAK OUTPUT VOLTAGE
vs
OUTPUT CURRENT

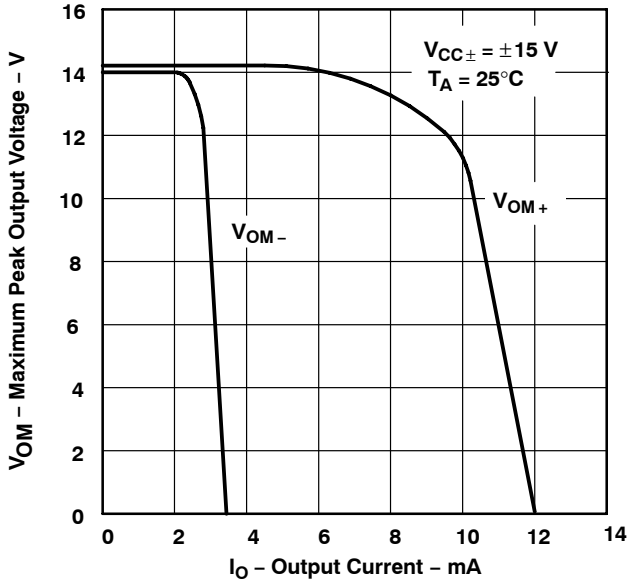


Figure 17

MAXIMUM PEAK OUTPUT VOLTAGE†
vs
FREE-AIR TEMPERATURE

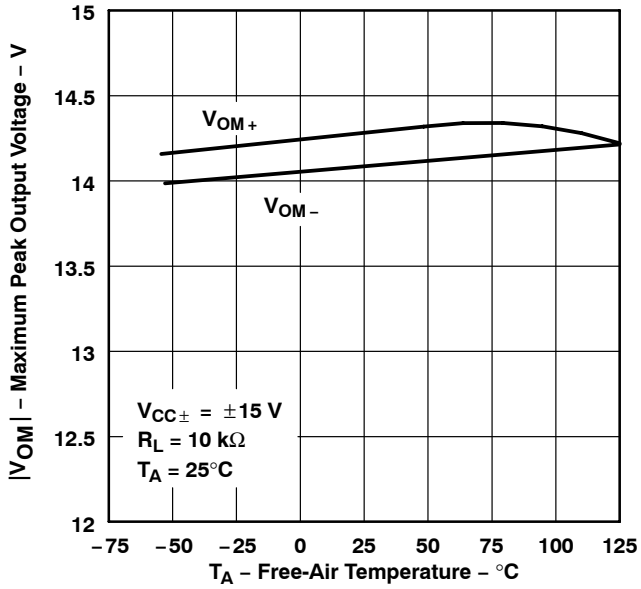


Figure 18

TLE2021
HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

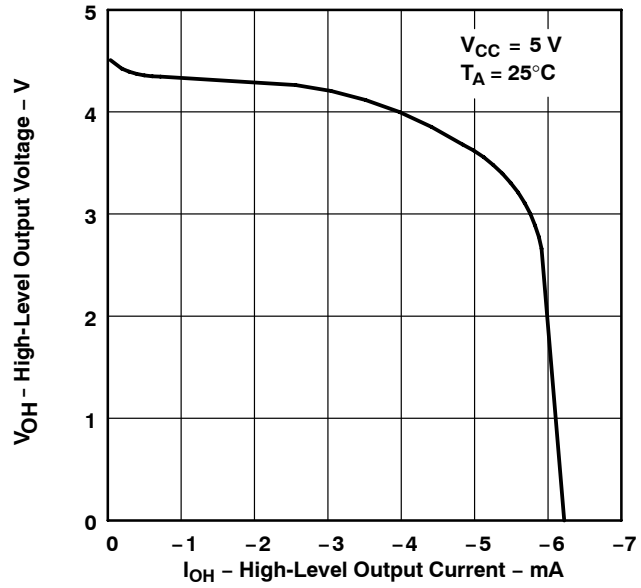


Figure 19

TLE2022 AND TLE2024
HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

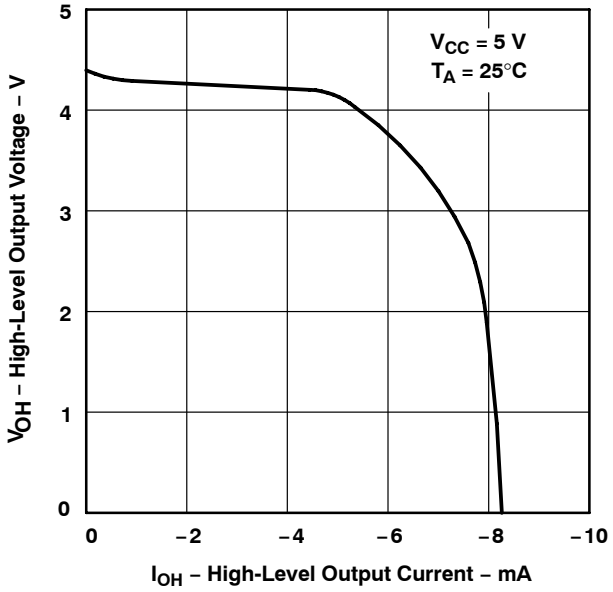


Figure 20

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

HIGH-LEVEL OUTPUT VOLTAGE† vs FREE-AIR TEMPERATURE

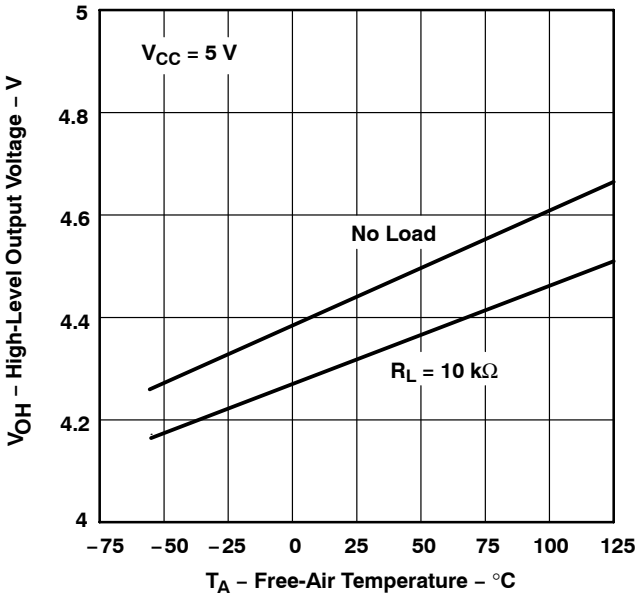


Figure 21

LOW-LEVEL OUTPUT VOLTAGE vs LOW-LEVEL OUTPUT CURRENT

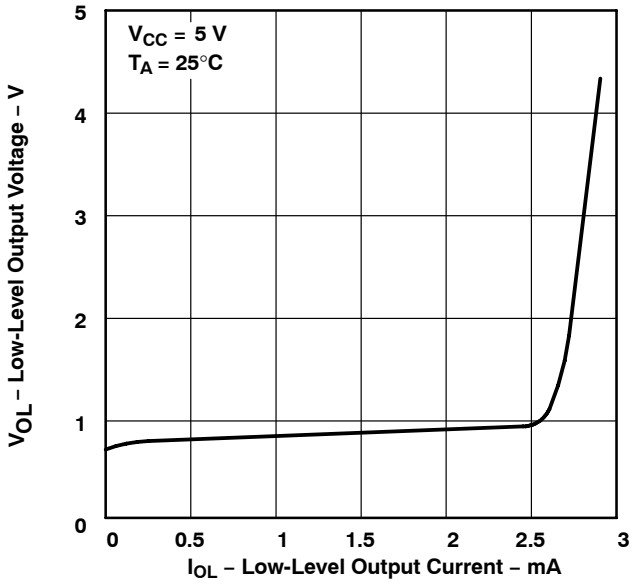


Figure 22

LOW-LEVEL OUTPUT VOLTAGE† vs FREE-AIR TEMPERATURE

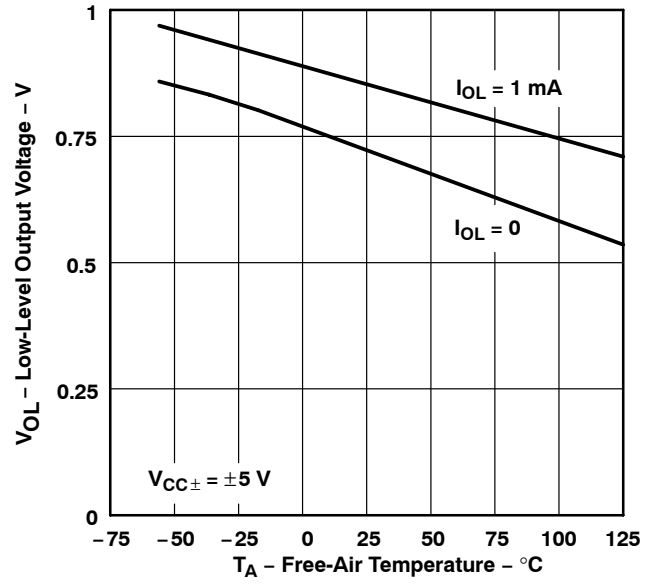


Figure 23

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE vs FREQUENCY

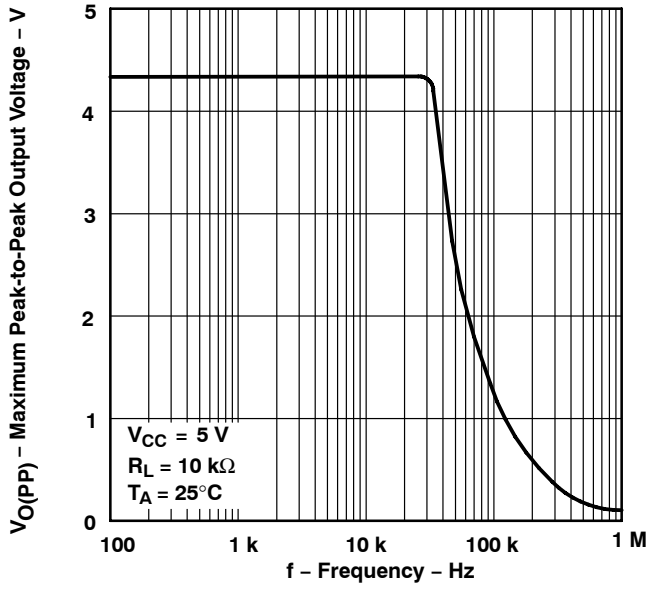


Figure 24

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE vs FREQUENCY

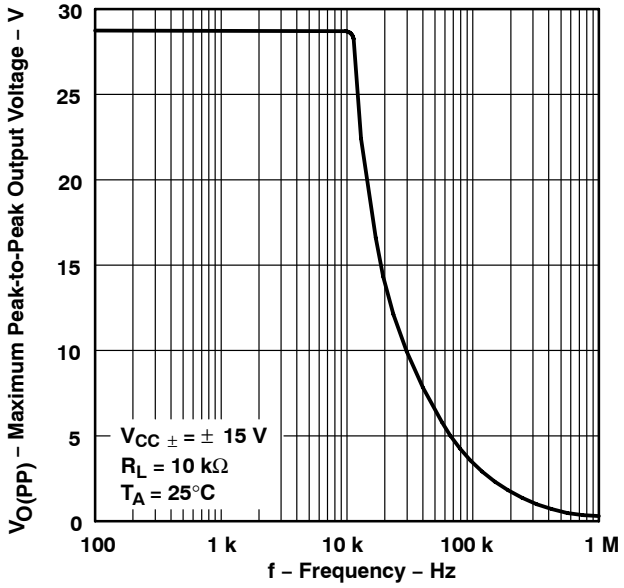


Figure 25

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT vs FREQUENCY

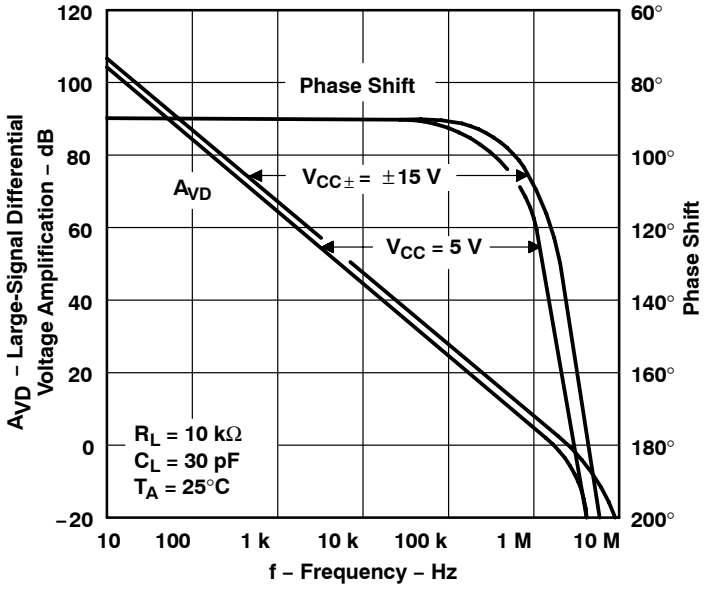


Figure 26

TYPICAL CHARACTERISTICS

TLE2021
LARGE-SCALE DIFFERENTIAL VOLTAGE AMPLIFICATION†
vs
FREE-AIR TEMPERATURE

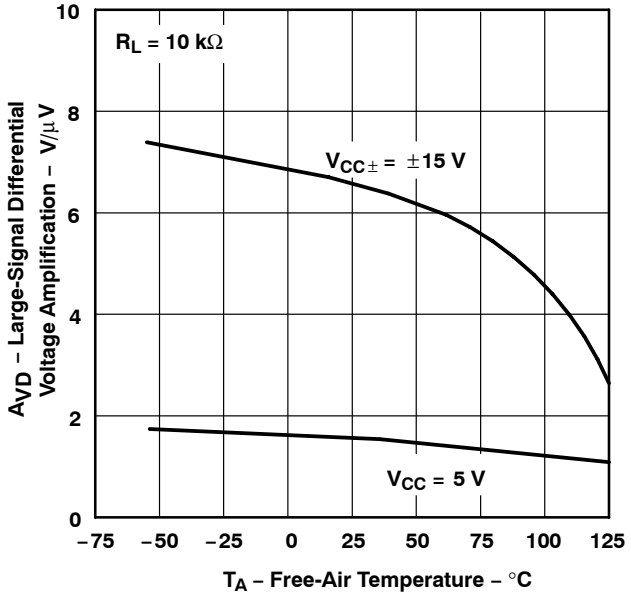


Figure 27

TLE2022
LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION†
vs
FREE-AIR TEMPERATURE

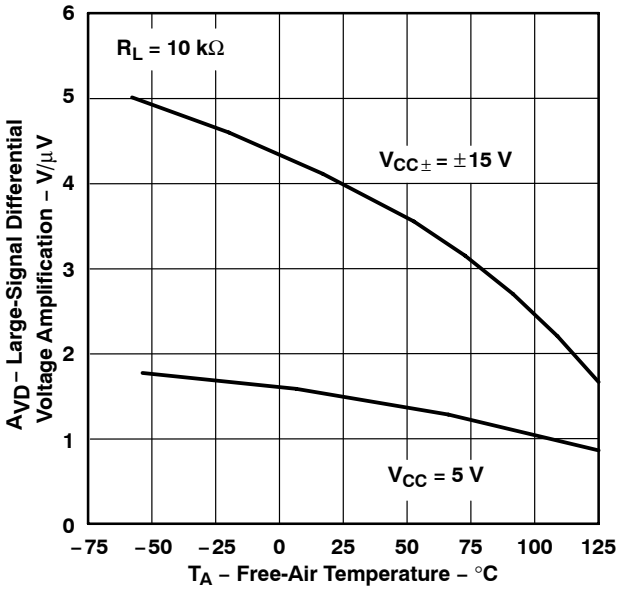


Figure 28

TLE2024
LARGE-SCALE DIFFERENTIAL VOLTAGE AMPLIFICATION†
vs
FREE-AIR TEMPERATURE

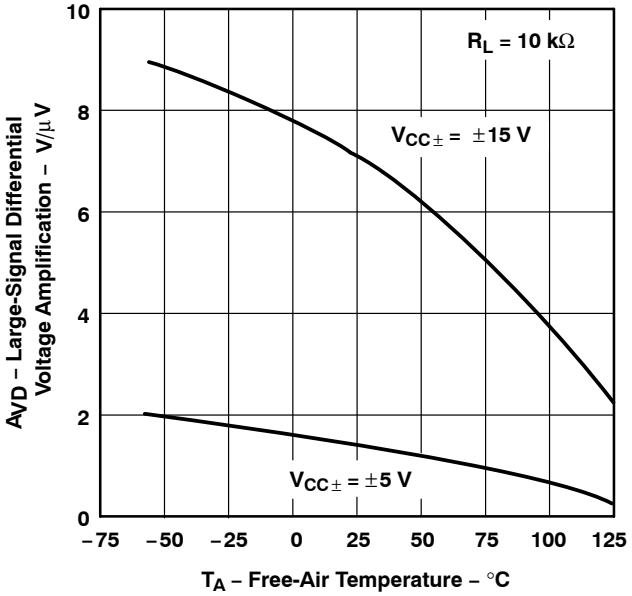


Figure 29

TLE2021
SHORT-CIRCUIT OUTPUT CURRENT
vs
SUPPLY VOLTAGE

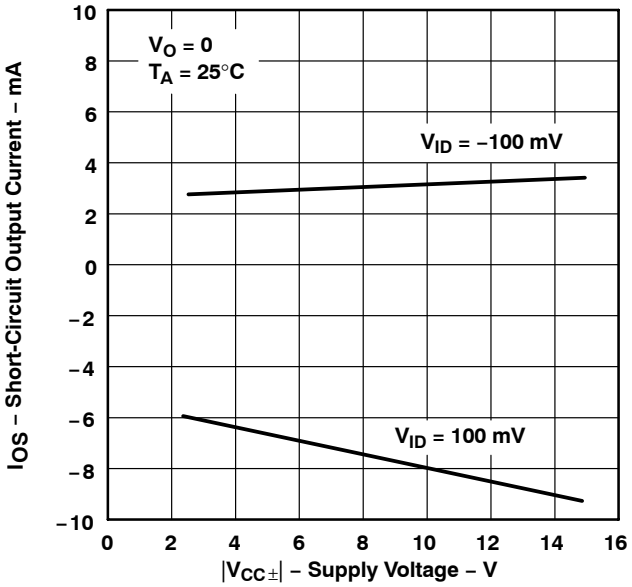


Figure 30

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**TLE2022 AND TLE2024
SHORT-CIRCUIT OUTPUT CURRENT
vs
SUPPLY VOLTAGE**

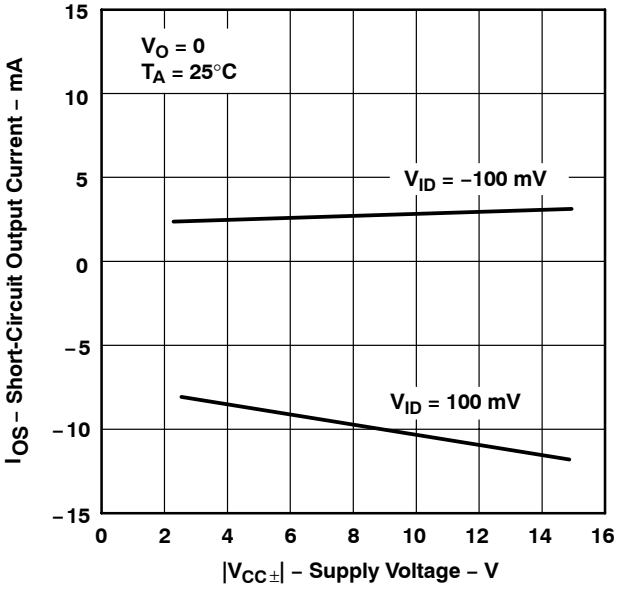


Figure 31

**TLE2021
SHORT-CIRCUIT OUTPUT CURRENT
vs
SUPPLY VOLTAGE**

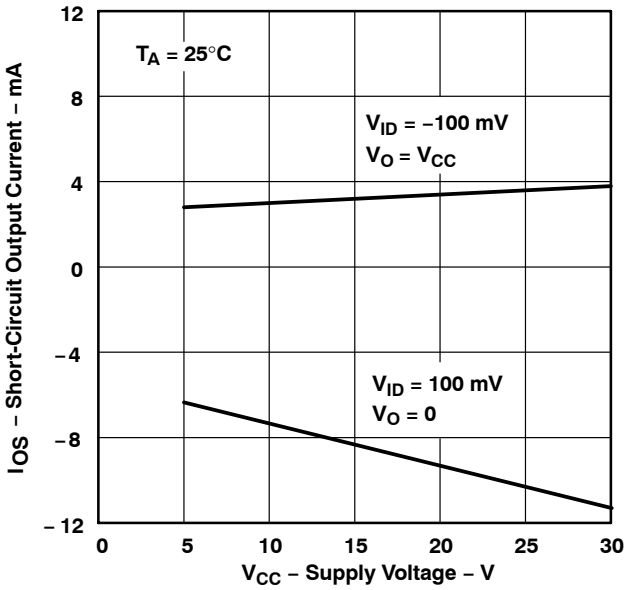


Figure 32

**TLE2022 AND TLE2024
SHORT-CIRCUIT OUTPUT CURRENT
vs
SUPPLY VOLTAGE**

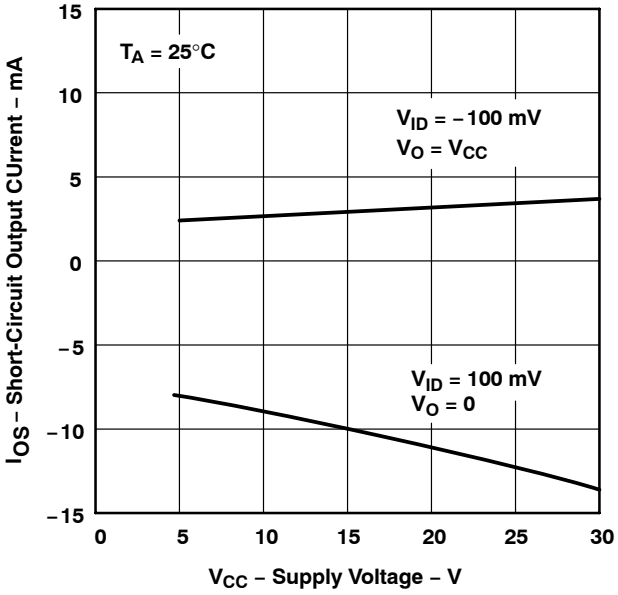


Figure 33

**TLE2021
SHORT-CIRCUIT OUTPUT CURRENT†
vs
FREE-AIR TEMPERATURE**

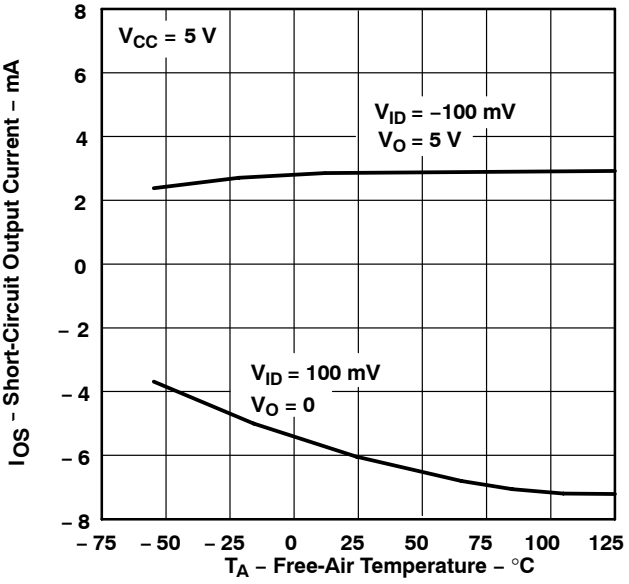


Figure 34

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**TLE2022 AND TLE2024
SHORT-CIRCUIT OUTPUT CURRENT† vs FREE-AIR TEMPERATURE**

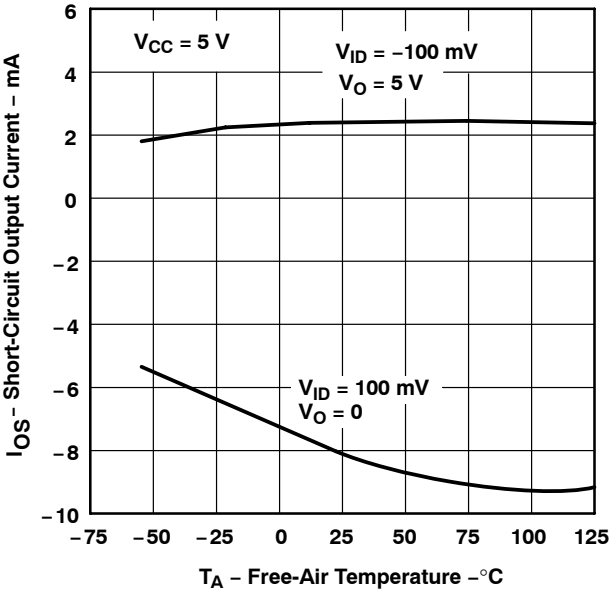


Figure 35

**TLE2021
SHORT-CIRCUIT OUTPUT CURRENT† vs FREE-AIR TEMPERATURE**

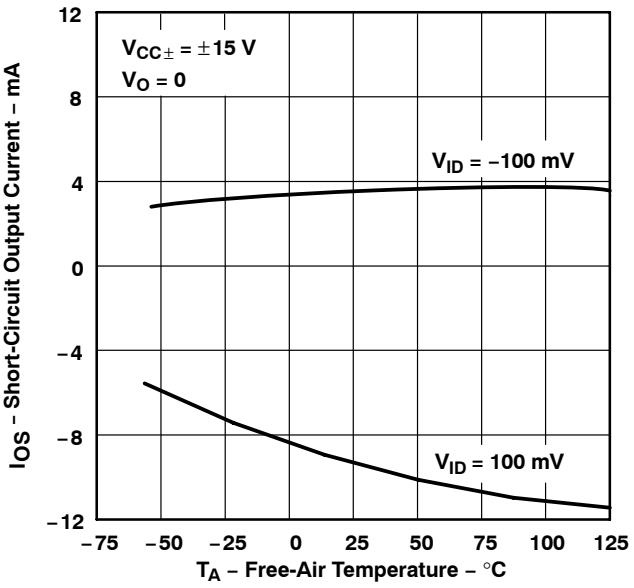


Figure 36

**TLE2022 AND TLE2024
SHORT-CIRCUIT OUTPUT CURRENT† vs FREE-AIR TEMPERATURE**

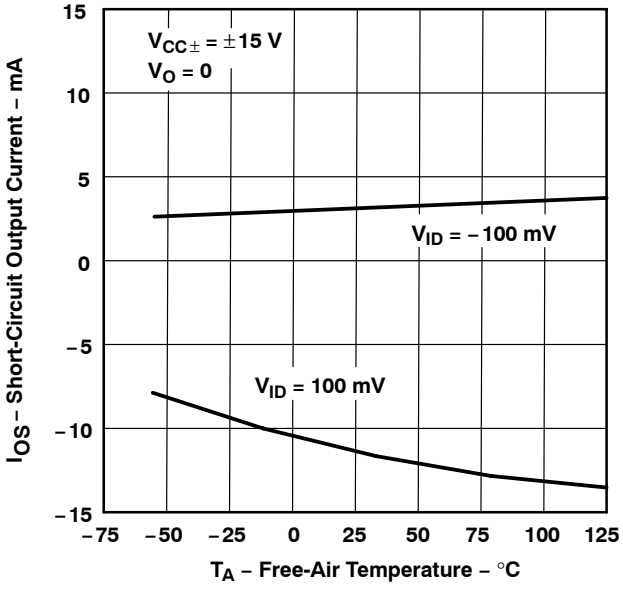


Figure 37

**TLE2021
SUPPLY CURRENT vs SUPPLY VOLTAGE**

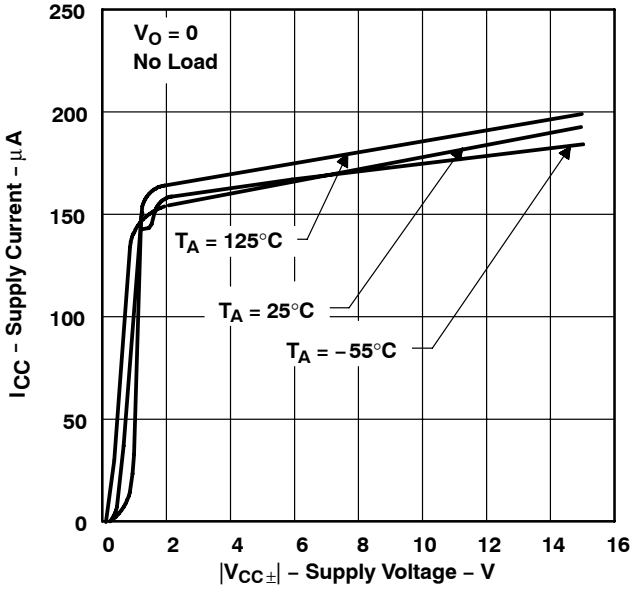


Figure 38

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**TLE2022
SUPPLY CURRENT
vs
SUPPLY VOLTAGE**

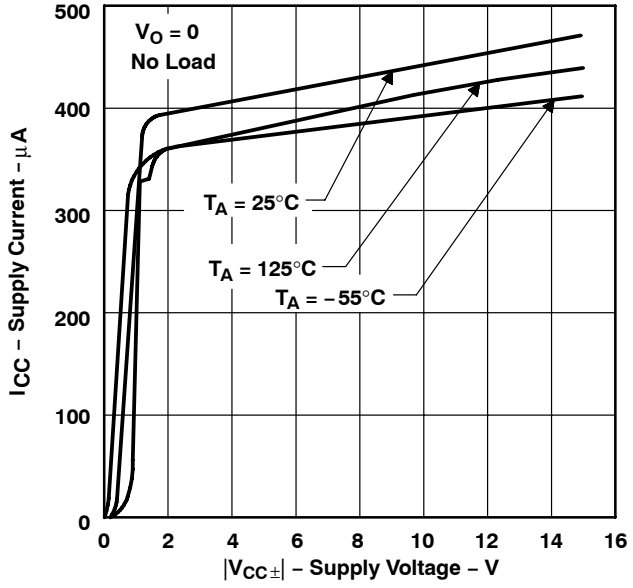


Figure 39

**TLE2024
SUPPLY CURRENT
vs
SUPPLY VOLTAGE**

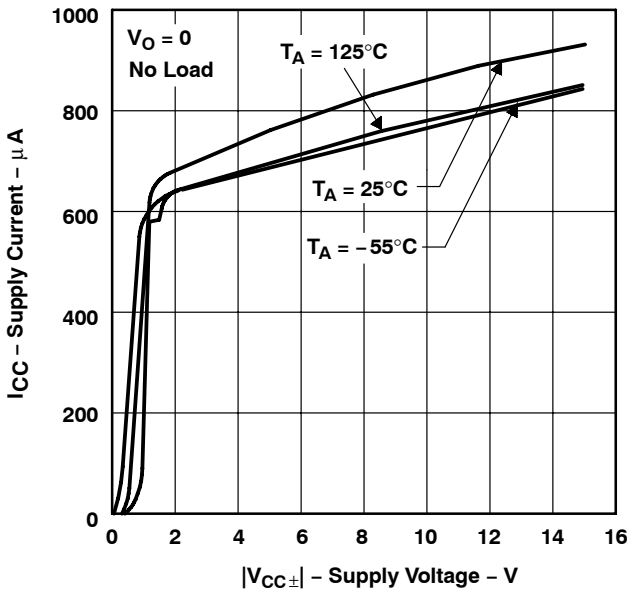


Figure 40

**TLE2021
SUPPLY CURRENT†
vs
FREE-AIR TEMPERATURE**

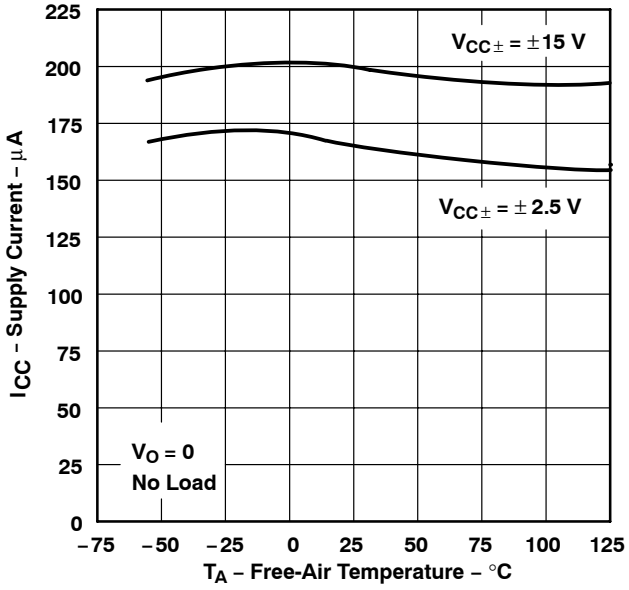


Figure 41

**TLE2022
SUPPLY CURRENT†
vs
FREE-AIR TEMPERATURE**

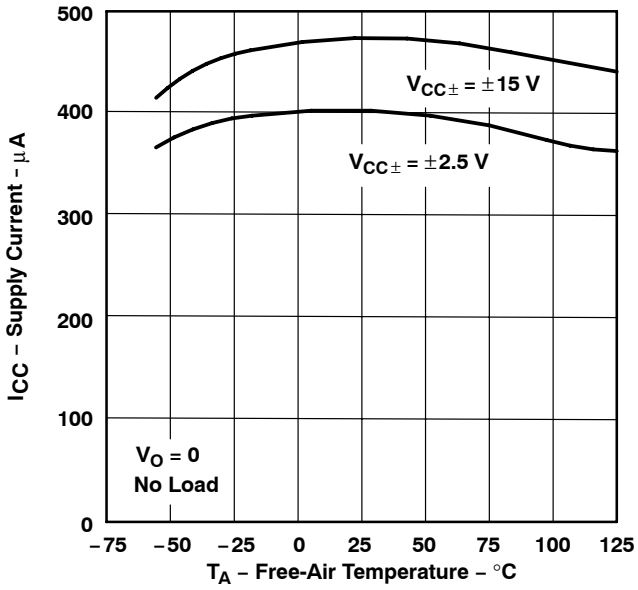


Figure 42

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2024
SUPPLY CURRENT† vs FREE-AIR TEMPERATURE

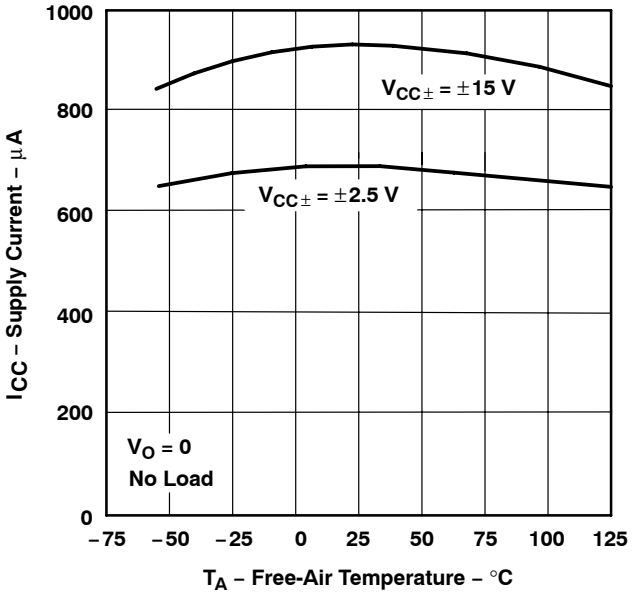


Figure 43

TLE2021
COMMON-MODE REJECTION RATIO vs FREQUENCY

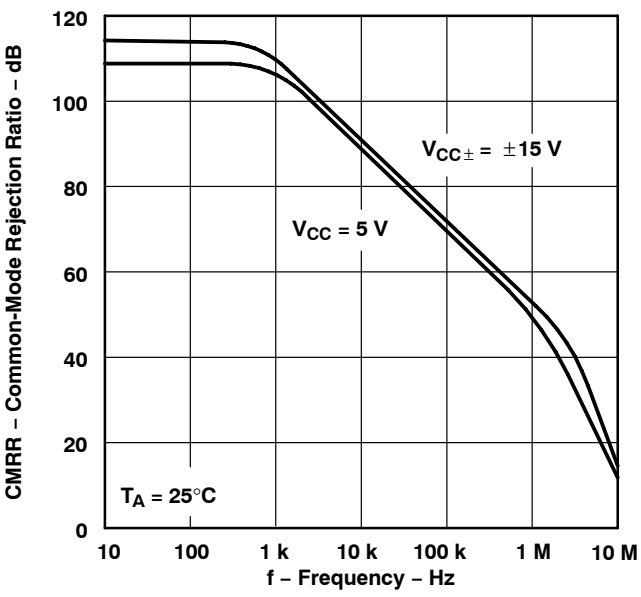


Figure 44

TLE2022
COMMON-MODE REJECTION RATIO vs FREQUENCY

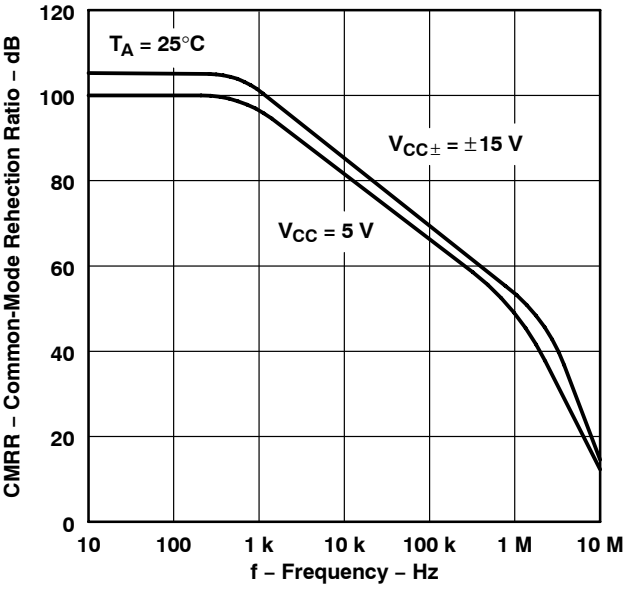


Figure 45

TLE2024
COMMON-MODE REJECTION RATIO vs FREQUENCY

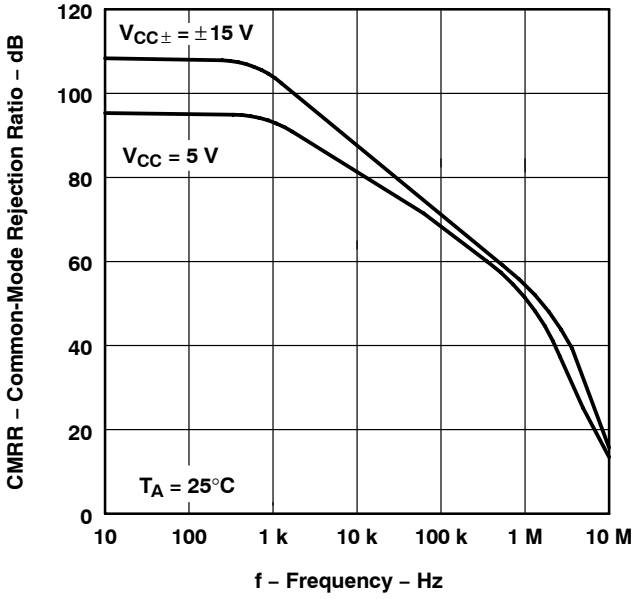


Figure 46

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

TLE2021
SLEW RATE†
vs
FREE-AIR TEMPERATURE

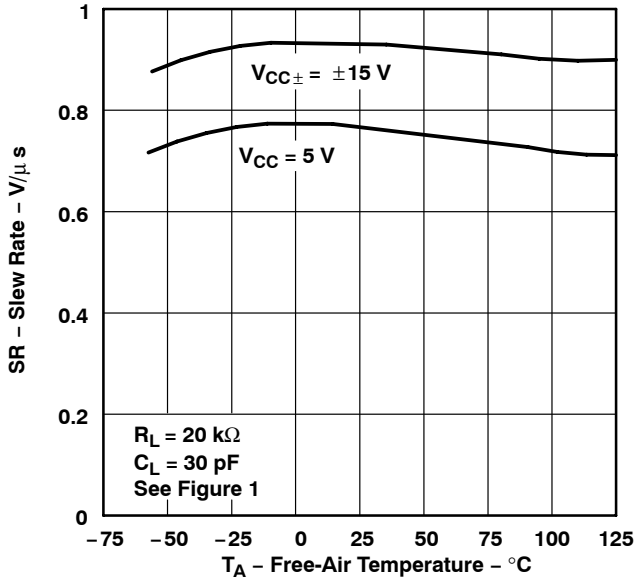


Figure 47

TLE2022
SLEW RATE†
vs
FREE-AIR TEMPERATURE

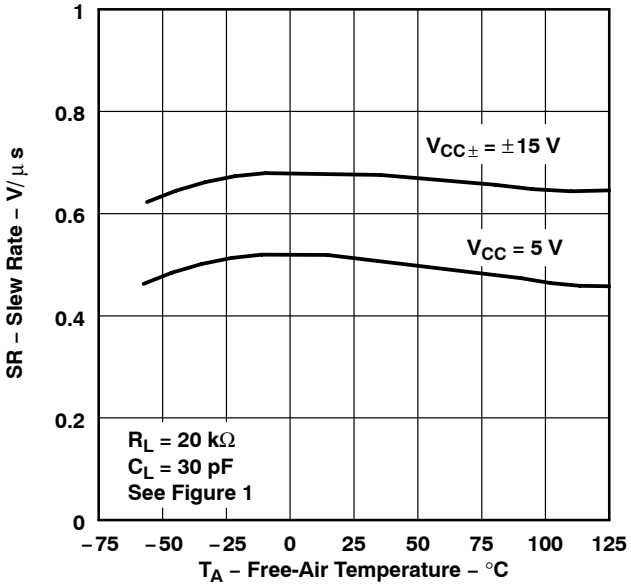


Figure 48

TLE2024
SLEW RATE†
vs
FREE-AIR TEMPERATURE

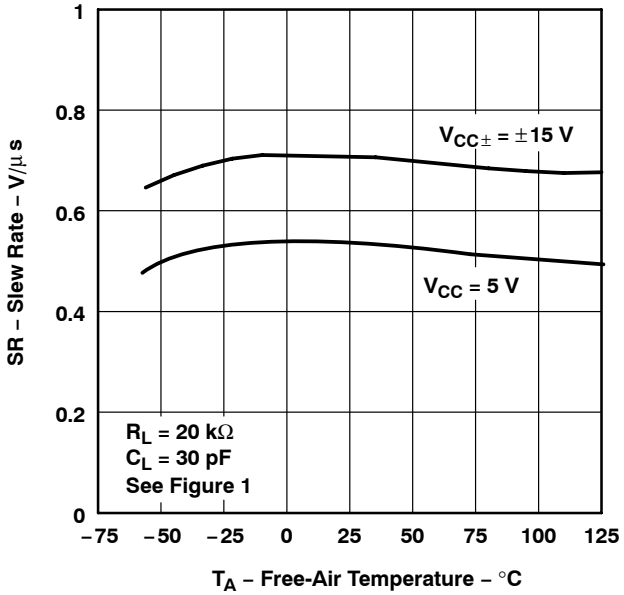


Figure 49

VOLTAGE-FOLLOWER
SMALL-SIGNAL
PULSE RESPONSE

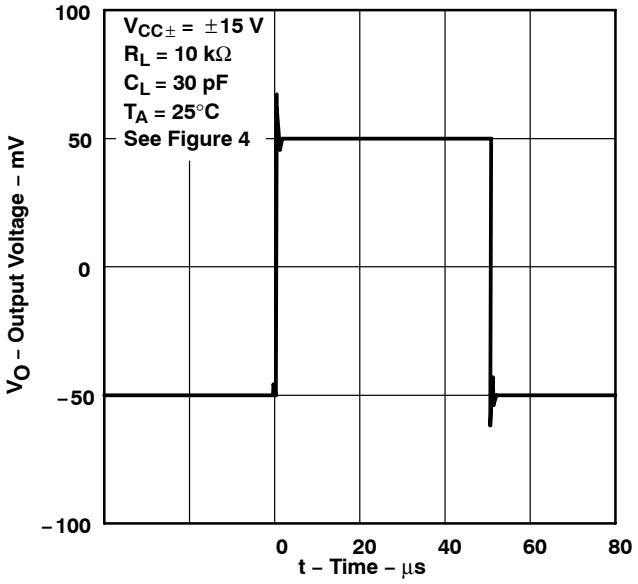


Figure 50

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE

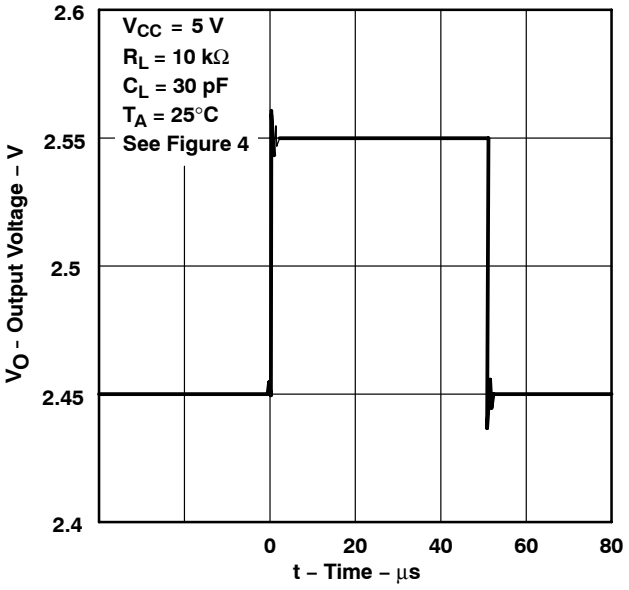


Figure 51

TLE2021 VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

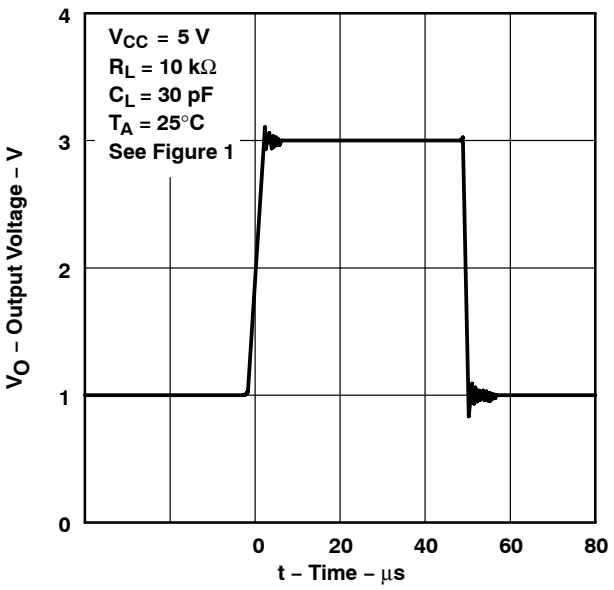


Figure 52

TLE2022 VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

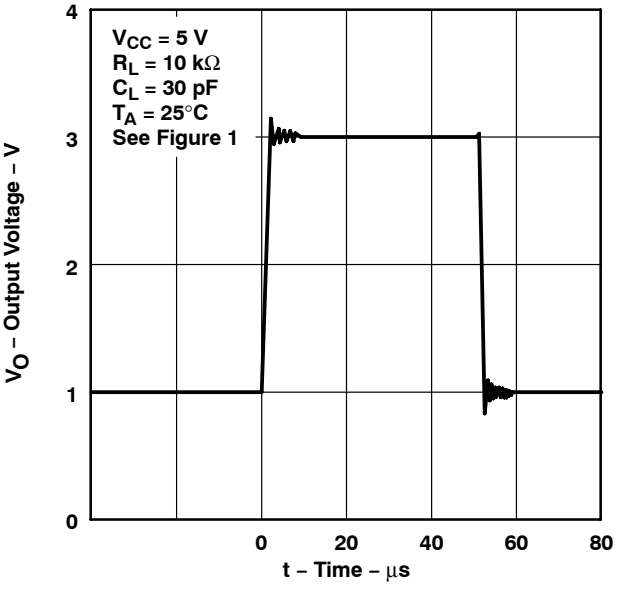


Figure 53

TLE2024 VOLTAGE-FOLLOWER LARGE-SCALE PULSE RESPONSE

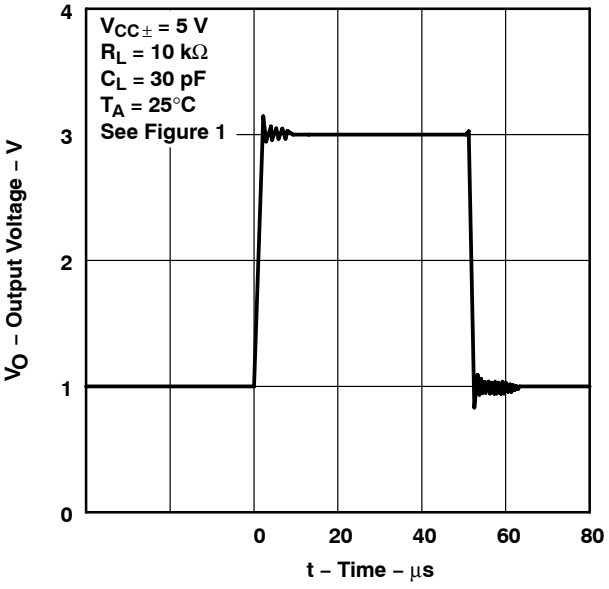


Figure 54

TYPICAL CHARACTERISTICS

TLE2021
VOLTAGE-FOLLOWER LARGE-SIGNAL
PULSE RESPONSE

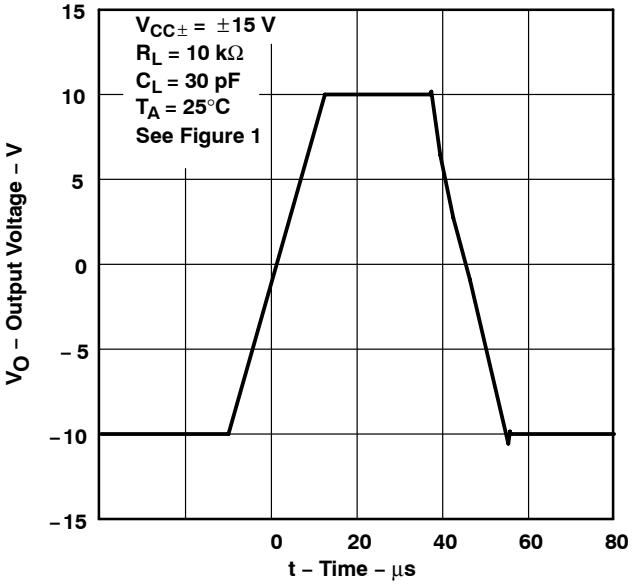


Figure 55

TLE2022
VOLTAGE-FOLLOWER LARGE-SIGNAL
PULSE RESPONSE

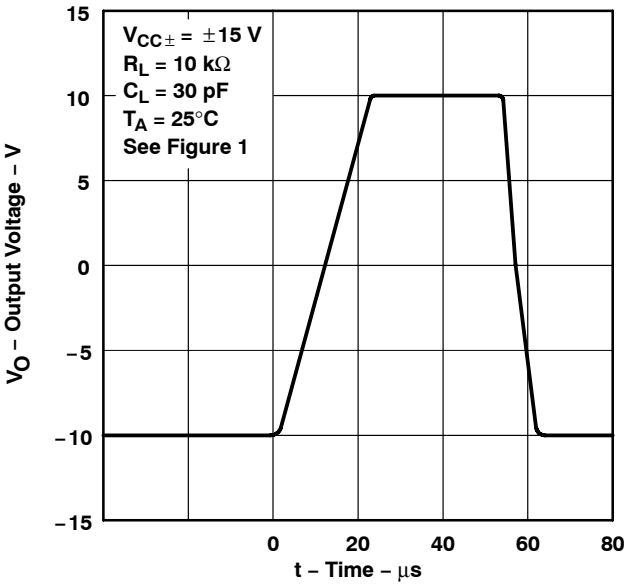


Figure 56

TLE2024
VOLTAGE-FOLLOWER LARGE-SIGNAL
PULSE RESPONSE

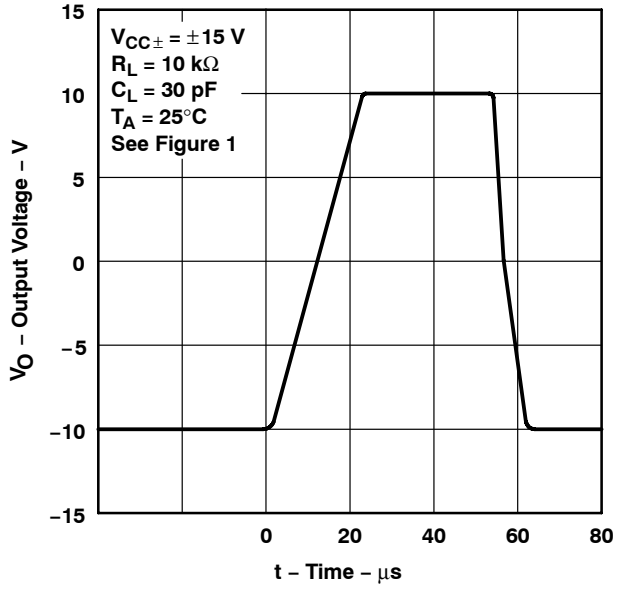


Figure 57

PEAK-TO-PEAK EQUIVALENT
INPUT NOISE VOLTAGE
0.1 TO 1 Hz

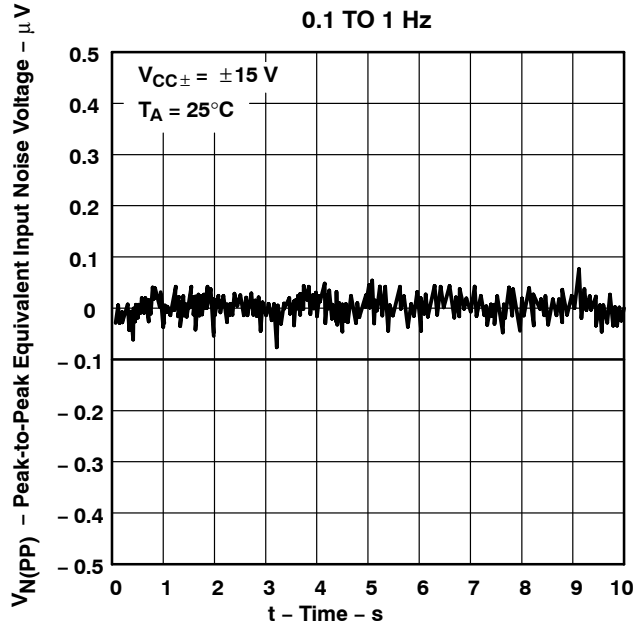


Figure 58

TYPICAL CHARACTERISTICS

PEAK-TO-PEAK EQUIVALENT INPUT NOISE VOLTAGE 0.1 TO 10 Hz

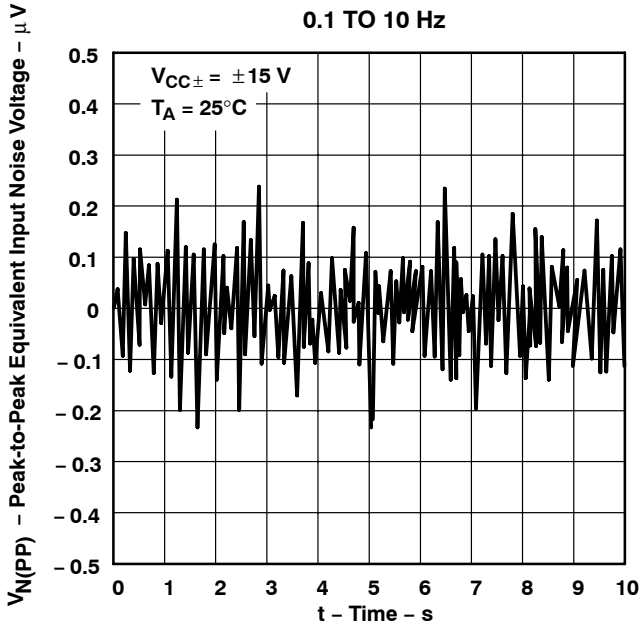


Figure 59

EQUIVALENT INPUT NOISE VOLTAGE vs FREQUENCY

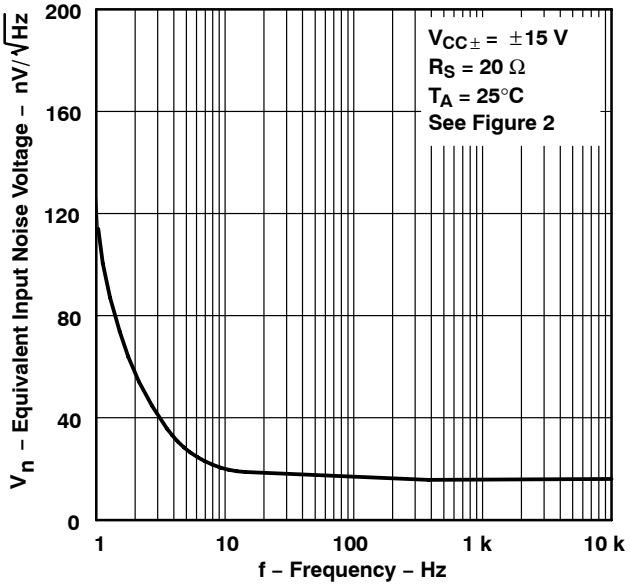


Figure 60

TLE2021 UNITY-GAIN BANDWIDTH vs SUPPLY VOLTAGE

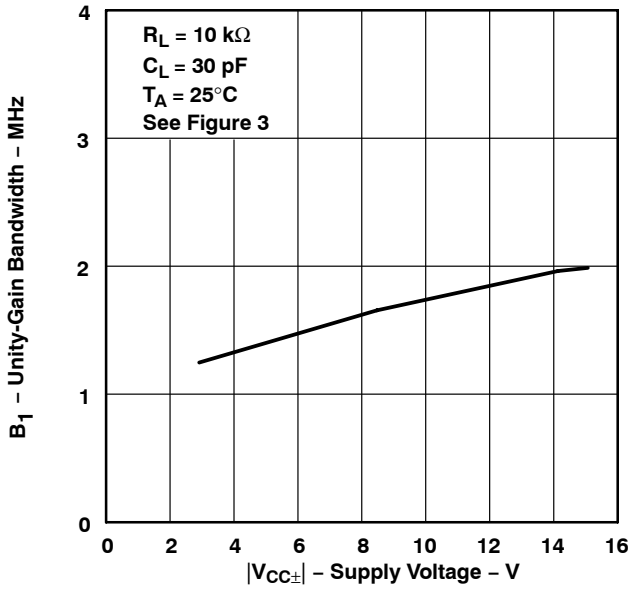


Figure 61

TLE2022 AND TLE2024 UNITY-GAIN BANDWIDTH vs SUPPLY VOLTAGE

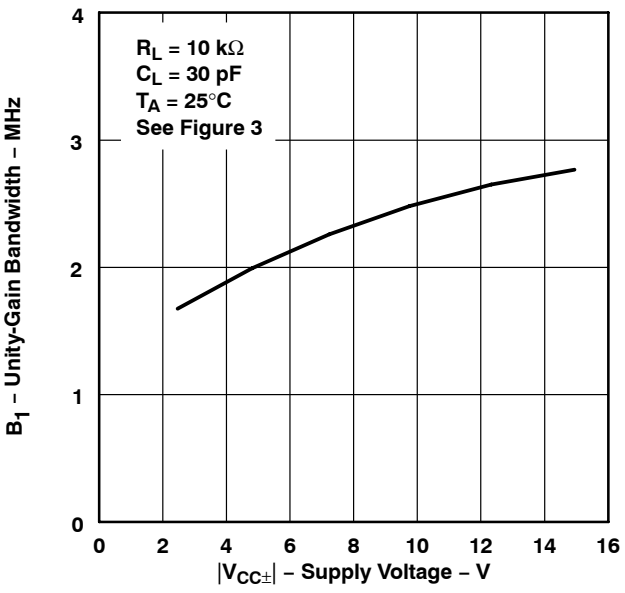


Figure 62

TYPICAL CHARACTERISTICS

TLE2021
UNITY-GAIN BANDWIDTH†
vs
FREE-AIR TEMPERATURE

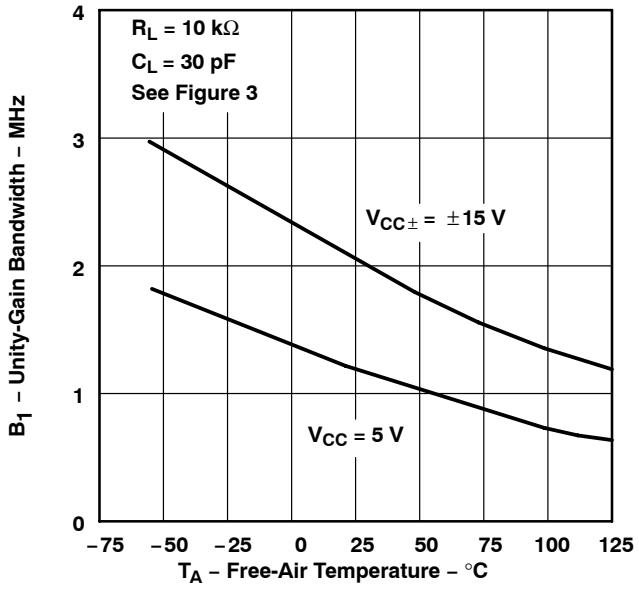


Figure 63

TLE2022 AND TLE2024
UNITY-GAIN BANDWIDTH†
vs
FREE-AIR TEMPERATURE

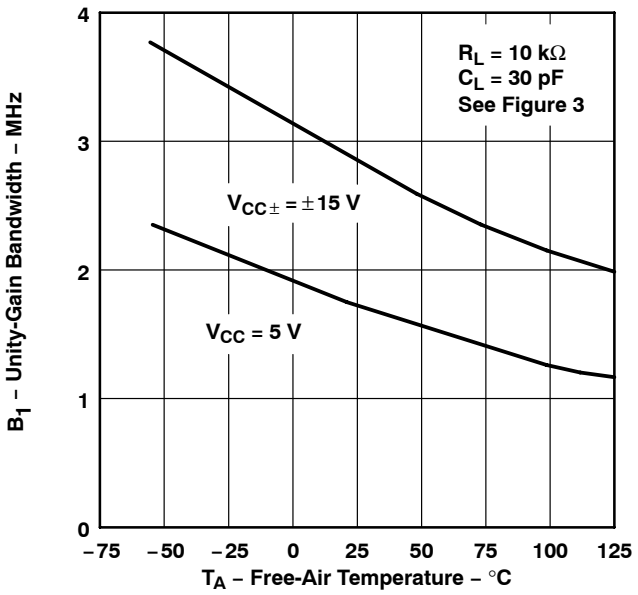


Figure 64

TLE2021
PHASE MARGIN
vs
SUPPLY VOLTAGE

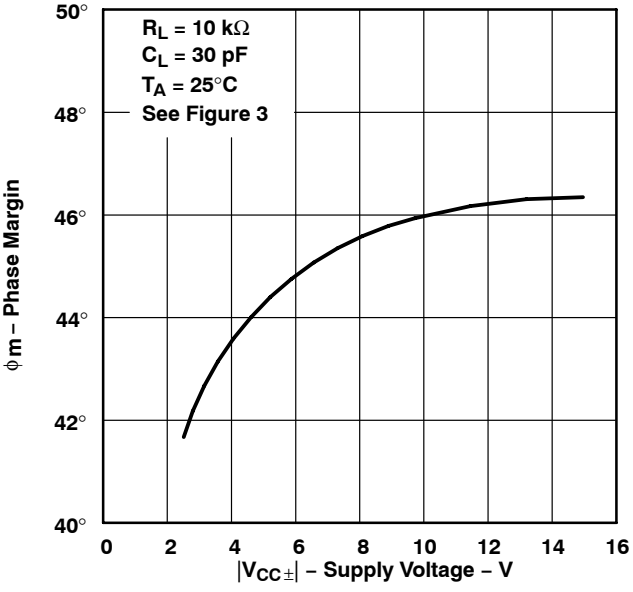


Figure 65

TLE2022 AND TLE2024
PHASE MARGIN
vs
SUPPLY VOLTAGE

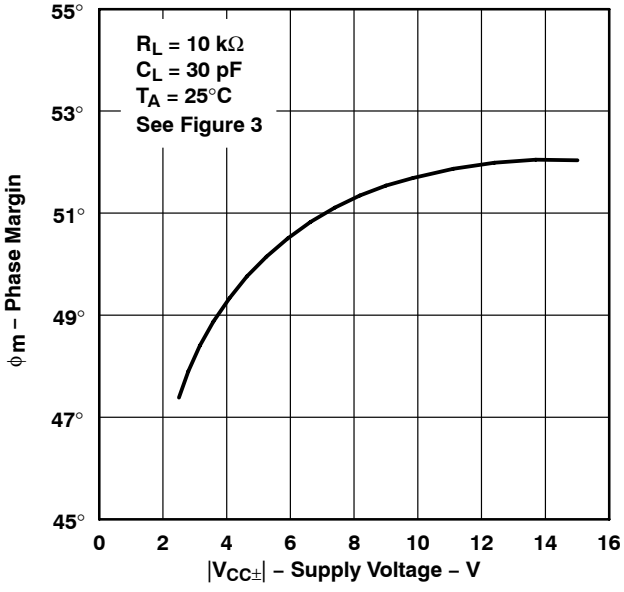


Figure 66

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**TLE2021
PHASE MARGIN
vs
LOAD CAPACITANCE**

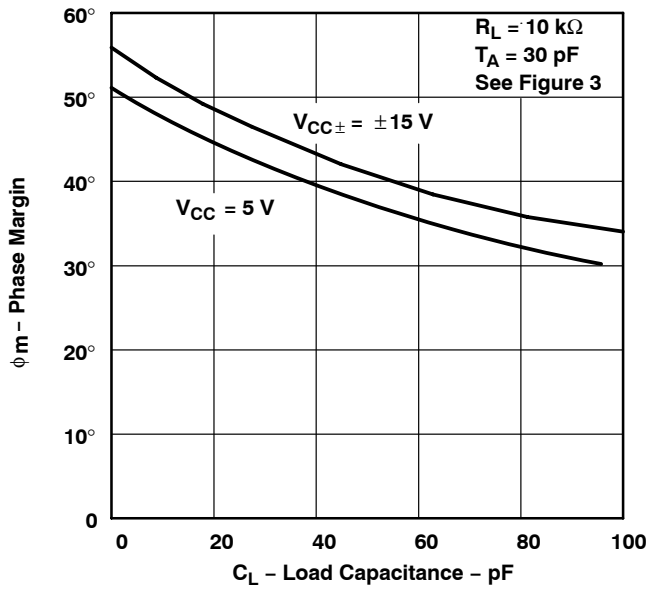


Figure 67

**TLE2022 AND TLE2024
PHASE MARGIN
vs
LOAD CAPACITANCE**

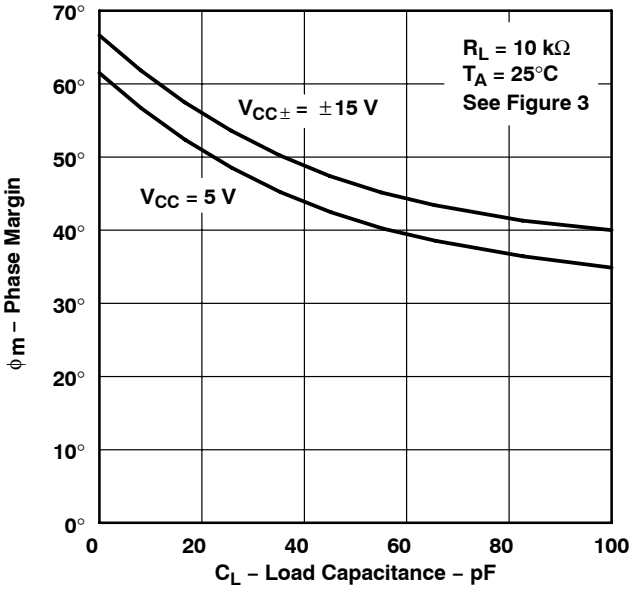


Figure 68

**TLE2021
PHASE MARGIN†
vs
FREE-AIR TEMPERATURE**

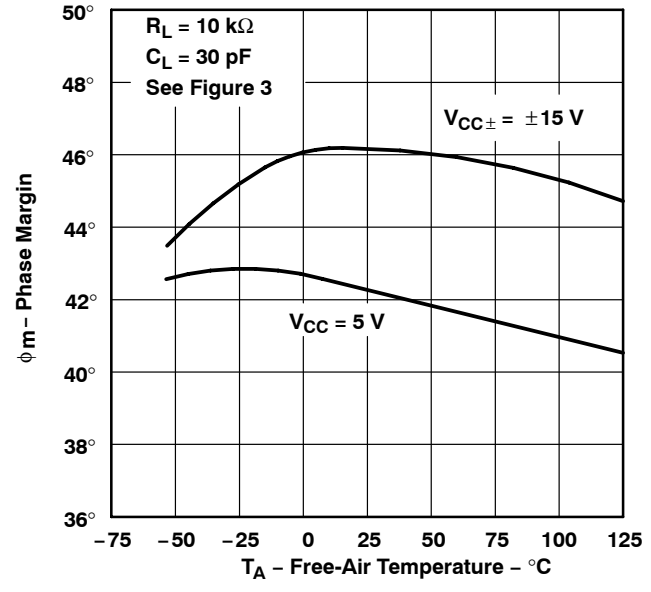


Figure 69

**TLE2022 AND TLE2024
PHASE MARGIN†
vs
FREE-AIR TEMPERATURE**

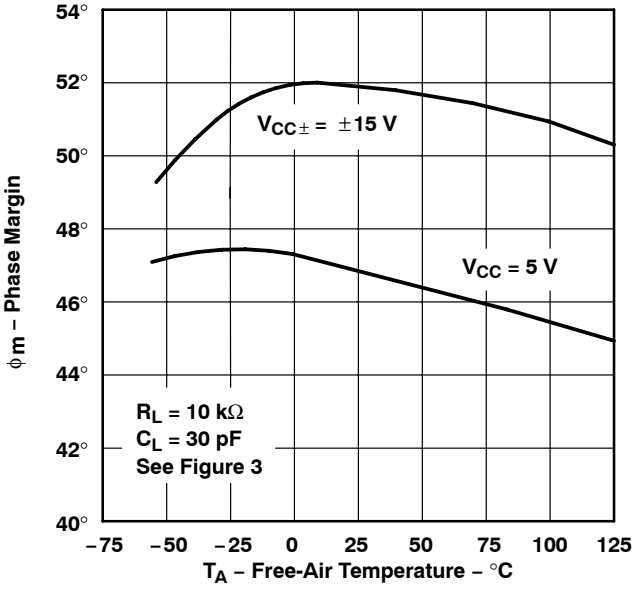


Figure 70

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

voltage-follower applications

The TLE202x circuitry includes input-protection diodes to limit the voltage across the input transistors; however, no provision is made in the circuit to limit the current if these diodes are forward biased. This condition can occur when the device is operated in the voltage-follower configuration and driven with a fast, large-signal pulse. It is recommended that a feedback resistor be used to limit the current to a maximum of 1 mA to prevent degradation of the device. This feedback resistor forms a pole with the input capacitance of the device. For feedback resistor values greater than 10 kΩ, this pole degrades the amplifier phase margin. This problem can be alleviated by adding a capacitor (20 pF to 50 pF) in parallel with the feedback resistor (see Figure 71).

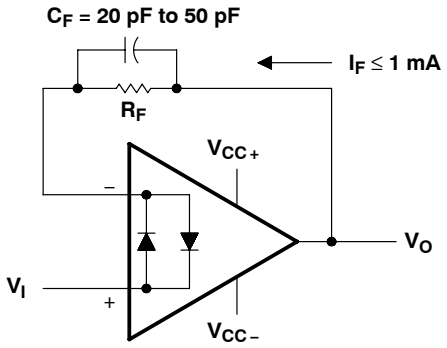


Figure 71. Voltage Follower

Input offset voltage nulling

The TLE202x series offers external null pins that further reduce the input offset voltage. The circuit in Figure 72 can be connected as shown if this feature is desired. When external nulling is not needed, the null pins may be left disconnected.

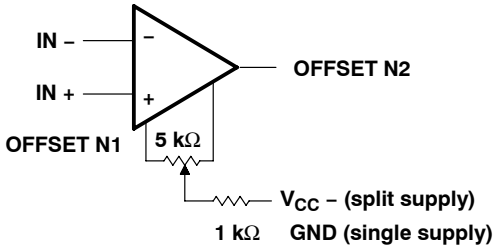


Figure 72. Input Offset Voltage Null Circuit

APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim *Parts*™, the model generation software used with Microsim *PSpice*™. The Boyle macromodel (see Note 5) and subcircuit in Figure 73, Figure 74, and Figure 75 were generated using the TLE202x typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 5: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).

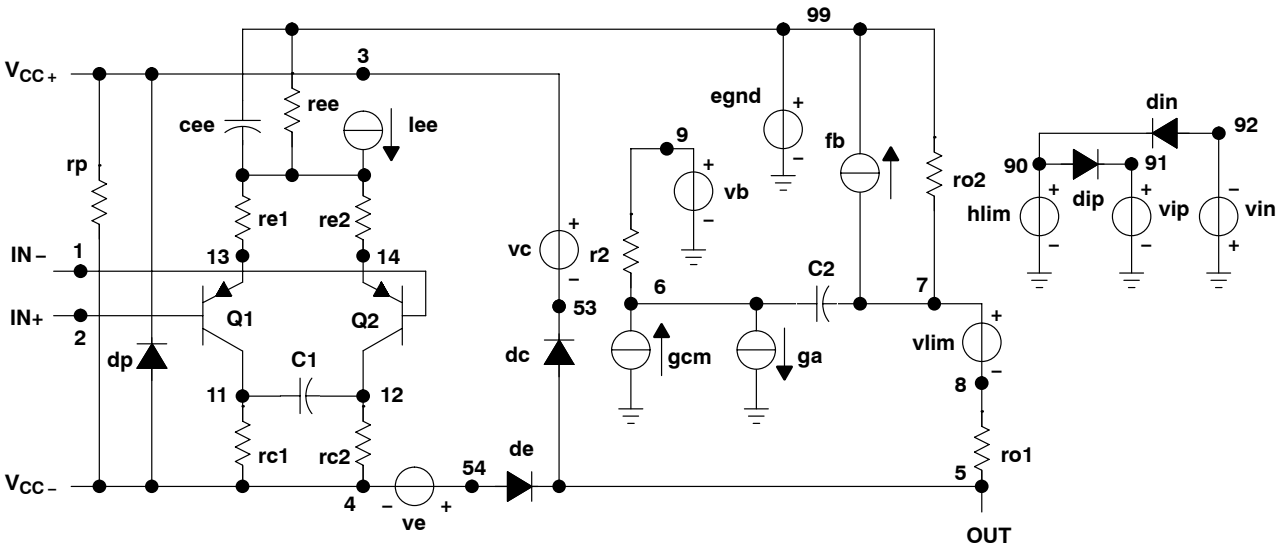


Figure 73. Boyle Subcircuit

PSpice and *Parts* are trademarks of MicroSim Corporation.

```
.SUBCKT TLE2021  1 2 3 4 5
*
  c1     11   12 6.244E-12
  c2     6    7  13.4E-12
  c3     87   0  10.64E-9
  cpsr   85   86 15.9E-9
  dcm+   81   82 dx
  dcm-   83   81 dx
  dc     5    53 dx
  de     54   5  dx
  dlp    90   91 dx
  dln    92   90 dx
  dp     4    3  dx
  ecmr   84   99 (2 99) 1
  egnd   99   0  poly(2) (3,0) (4,0) 0 .5 .5
  epsr   85   0  poly(1) (3,4) -60E-6  2.0E-6
  ense   89   2  poly(1) (88,0) 120E-6  1
  fb     7    99 poly(6) vb vc ve vlp vln vpsr 0 547.3E6
  + -50E7 50E7 50E7 -50E7 547E6
  ga     6    0  11 12 188.5E-6
  gcm    0    6  10 99 335.2E-12
  gpsr   85   86 (85,86) 100E-6
  grc1   4    11 (4,11) 1.885E-4
  grc2   4    12 (4,12) 1.885E-4
  gre1   13   10 (13,10) 6.82E-4
  gre2   14   10 (14,10) 6.82E-4
  hlim   90   0  vlim 1k
  hcmr   80   1  poly(2) vcm+ vcm- 0 1E2 1E2
  irp    3    4  185E-6
  iee    3    10 dc 15.67E-6
  iio    2    0  2E-9
  i1     88   0  1E-21
  q1     11   89 13 qx
  q2     12   80 14 qx
  R2     6    9  100.0E3
  rcm    84   81 1K
  ree    10   99 14.76E6
  rn1    87   0  2.55E8
  rn2    87   88 11.67E3
  ro1    8    5  62
  ro2    7    99 63
  vcm+   82   99 13.3
  vcm-   83   99 -14.6
  vb     9    0  dc 0
  vc     3    53 dc 1.300
  ve     54   4  dc 1.500
  vlim   7    8  dc 0
  vlp    91   0  dc 3.600
  vln    0    92 dc 3.600
  vpsr   0    86 dc 0
.model dx d(is=800.0E-18)
.model qx pnp(is=800.0E-18 bf=270)
.ends
```

Figure 74. Boyle Macromodel for the TLE2021

```
.SUBCKT TLE2022  1 2 3 4 5
*
  c1    11  12 6.814E-12
  c2    6   7  20.00E-12
  dc    5   53 dx
  de    54  5  dx
  dlp   90  91 dx
  dln   92  90 dx
  dp    4   3  dx
  egnd  99  0  poly(2) (3,0) (4,0) 0 .5 .5
  fb    7   99 poly(5) vb vc ve vlp vln 0
+ 45.47E6 -50E6 50E6 50E6 -50E6
  ga 6  0   11 12 377.9E-6
  gcm 0 6   10 99 7.84E-10
  iee   3   10 DC 18.07E-6
  hlim 90   0 vlim 1k
  q1    11  2 13 qx
  q2    12  1 14 qx
  r2    6   9 100.0E3
  rc1   4   11 2.842E3
  rc2   4   12 2.842E3
  ge1   13  10 (10,13) 31.299E-3
  ge2   14  10 (10,14) 31.299E-3
  ree   10  99 11.07E6
  ro1   8   5 250
  ro2   7   99 250
  rp    3   4 137.2E3
  vb    9   0 dc 0
  vc    3   53 dc 1.300
  ve    54  4 dc 1.500
  vlim  7   8 dc 0
  vlp   91  0 dc 3
  vln   0   92 dc 3
.model dx  d(is=800.0E-18)
.model qx  pnp(is=800.0E-18 bf=257.1)
.ends
```

Figure 75. Boyle Macromodel for the TLE2022

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9088101MPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088101MPA TLE2021M	Samples
5962-9088102M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088102M2A TLE2022MFKB	Samples
5962-9088102MPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088102MPA TLE2022M	Samples
5962-9088103M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088103M2A TLE2024MFKB	Samples
5962-9088103MCA	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088103MCA TLE2024MJB	Samples
5962-9088104Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088104Q2A TLE2021 AMFKB	Samples
5962-9088104QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088104QPA TLE2021AM	Samples
5962-9088105Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088105Q2A TLE2022A MFKB	Samples
5962-9088105QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088105QPA TLE2022AM	Samples
5962-9088106Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088106Q2A TLE2024A MFKB	Samples
5962-9088106QCA	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088106QCA TLE2024AMJB	Samples
5962-9088107Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088107Q2A TLE2021 BMFKB	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9088107QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088107QPA TLE2021BM	Samples
5962-9088108Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088108Q2A TLE2022B MFKB	Samples
5962-9088108QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088108QPA TLE2022BM	Samples
5962-9088109Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088109Q2A TLE2024 BMFKB	Samples
5962-9088109QCA	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088109QCA TLE2024BMJB	Samples
TLE2021ACD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2021AC	Samples
TLE2021ACDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2021AC	Samples
TLE2021ACP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2021AC	Samples
TLE2021AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2021AI	Samples
TLE2021AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2021AI	Samples
TLE2021AIP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2021AI	Samples
TLE2021AMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088104Q2A TLE2021 AMFKB	Samples
TLE2021AMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088104QPA TLE2021AM	Samples
TLE2021BMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type		5962-9088107Q2A TLE2021 BMFKB	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLE2021BMJG	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	TLE2021 BMJG	Samples
TLE2021BMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type		9088107QPA TLE2021BM	Samples
TLE2021CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2021C	Samples
TLE2021CDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2021C	Samples
TLE2021CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2021C	Samples
TLE2021CP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TLE2021CP	Samples
TLE2021CPE4	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TLE2021CP	Samples
TLE2021ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2021I	Samples
TLE2021IDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2021I	Samples
TLE2021IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2021I	Samples
TLE2021IDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2021I	Samples
TLE2021IP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TLE2021IP	Samples
TLE2021MD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	2021M	Samples
TLE2021MDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2021M	Samples
TLE2021MJG	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	TLE2021MJG	Samples
TLE2021MJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088101MPA TLE2021M	Samples
TLE2022ACD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2022AC	Samples
TLE2022ACDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2022AC	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLE2022ACDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022AC	Samples
TLE2022ACDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022AC	Samples
TLE2022ACP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022AC	Samples
TLE2022ACPE4	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022AC	Samples
TLE2022AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2022AI	Samples
TLE2022AIDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2022AI	Samples
TLE2022AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022AI	Samples
TLE2022AIP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022AI	Samples
TLE2022AMD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	2022AM	Samples
TLE2022AMDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022AM	Samples
TLE2022AMDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	2022AM	Samples
TLE2022AMDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022AM	Samples
TLE2022AMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088105Q2A TLE2022A MFKB	Samples
TLE2022AMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088105QPA TLE2022AM	Samples
TLE2022BMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088108Q2A TLE2022B MFKB	Samples
TLE2022BMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088108QPA TLE2022BM	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLE2022CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022C	Samples
TLE2022CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2022C	Samples
TLE2022CP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022CP	Samples
TLE2022CPE4	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022CP	Samples
TLE2022ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2022I	Samples
TLE2022IDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2022I	Samples
TLE2022IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	2022I	Samples
TLE2022IP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022IP	Samples
TLE2022IPE4	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2022IP	Samples
TLE2022MD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	2022M	Samples
TLE2022MDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022M	Samples
TLE2022MDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	2022M	Samples
TLE2022MDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2022M	Samples
TLE2022MFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088102M2A TLE2022MFKB	Samples
TLE2022MJG	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	TLE2022MJG	Samples
TLE2022MJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9088102MPA TLE2022M	Samples
TLE2024ACDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024AC	Samples
TLE2024ACDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024AC	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLE2024ACN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2024ACN	Samples
TLE2024AIDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLE2024AI	Samples
TLE2024AIN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2024AIN	Samples
TLE2024AMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088106Q2A TLE2024A MFKB	Samples
TLE2024AMJB	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088106QCA TLE2024AMJB	Samples
TLE2024BMDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2024BM	Samples
TLE2024BMDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024BM	Samples
TLE2024BMDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2024BM	Samples
TLE2024BMFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088109Q2A TLE2024 BMFKB	Samples
TLE2024BMJ	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	TLE2024BMJ	Samples
TLE2024BMJB	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088109QCA TLE2024BMJB	Samples
TLE2024CDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024C	Samples
TLE2024CDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024C	Samples
TLE2024CDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024C	Samples
TLE2024CN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2024CN	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLE2024CNE4	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2024CN	Samples
TLE2024IDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		TLE2024I	Samples
TLE2024IN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type		TLE2024IN	Samples
TLE2024MDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2024M	Samples
TLE2024MDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2024M	Samples
TLE2024MFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962-9088103M2A TLE2024MFKB	Samples
TLE2024MJB	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9088103MCA TLE2024MJB	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TLE2021, TLE2021A, TLE2021AM, TLE2021M, TLE2022, TLE2022A, TLE2022AM, TLE2022M, TLE2024, TLE2024A, TLE2024AM, TLE2024B, TLE2024BM, TLE2024M :

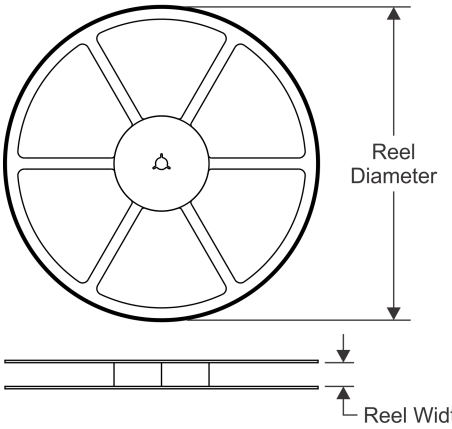
- Catalog: TLE2021A, TLE2021, TLE2022A, TLE2022, TLE2024A, TLE2024B, TLE2024
- Automotive: TLE2021-Q1, TLE2021A-Q1, TLE2021A-Q1, TLE2021-Q1, TLE2022-Q1, TLE2022A-Q1, TLE2022A-Q1, TLE2022-Q1, TLE2024-Q1, TLE2024A-Q1, TLE2024A-Q1, TLE2024-Q1
- Enhanced Product: TLE2021-EP, TLE2021A-EP, TLE2021A-EP, TLE2021-EP, TLE2022-EP, TLE2022A-EP, TLE2022A-EP, TLE2022-EP, TLE2024-EP, TLE2024A-EP, TLE2024A-EP, TLE2024-EP
- Military: TLE2021M, TLE2021AM, TLE2022M, TLE2022AM, TLE2024M, TLE2024AM, TLE2024BM

NOTE: Qualified Version Definitions:

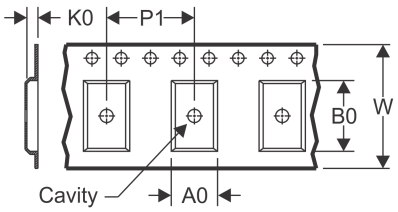
- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

REEL DIMENSIONS

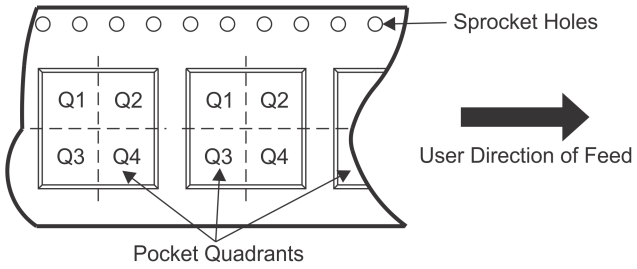


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

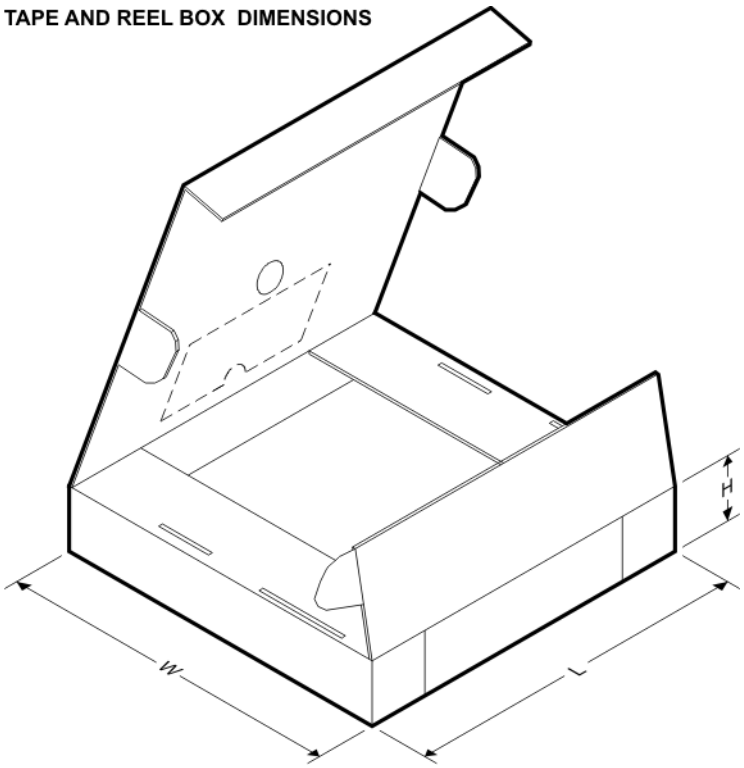
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLE2021ACDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2021AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2021CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2021IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022ACDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022AMDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022AMDRG4	SOIC	D	8	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2022MDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2024ACDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
TLE2024CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

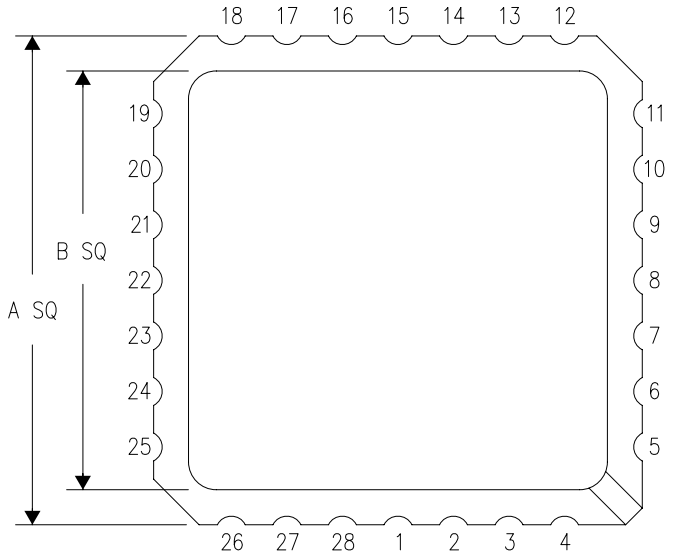


*All dimensions are nominal

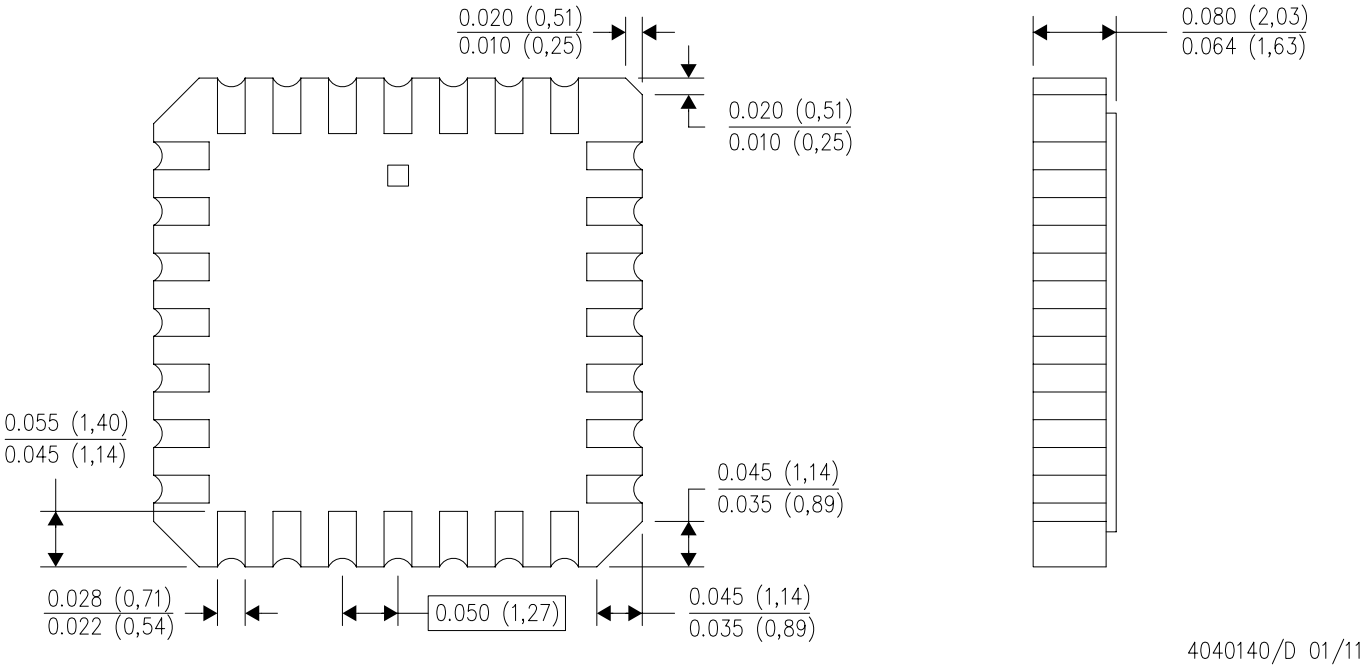
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLE2021ACDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2021AIDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2021CDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2021IDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022ACDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022AIDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022AMDR	SOIC	D	8	2500	350.0	350.0	43.0
TLE2022AMDRG4	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022CDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022IDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2022MDR	SOIC	D	8	2500	350.0	350.0	43.0
TLE2024ACDWR	SOIC	DW	16	2000	350.0	350.0	43.0
TLE2024CDWR	SOIC	DW	16	2000	350.0	350.0	43.0

FK (S–CQCC–N**) LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



NO. OF TERMINALS **	A		B	
	MIN	MAX	MIN	MAX
20	0.342 (8,69)	0.358 (9,09)	0.307 (7,80)	0.358 (9,09)
28	0.442 (11,23)	0.458 (11,63)	0.406 (10,31)	0.458 (11,63)
44	0.640 (16,26)	0.660 (16,76)	0.495 (12,58)	0.560 (14,22)
52	0.740 (18,78)	0.761 (19,32)	0.495 (12,58)	0.560 (14,22)
68	0.938 (23,83)	0.962 (24,43)	0.850 (21,6)	0.858 (21,8)
84	1.141 (28,99)	1.165 (29,59)	1.047 (26,6)	1.063 (27,0)



4040140/D 01/11

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. Falls within JEDEC MS–004

GENERIC PACKAGE VIEW

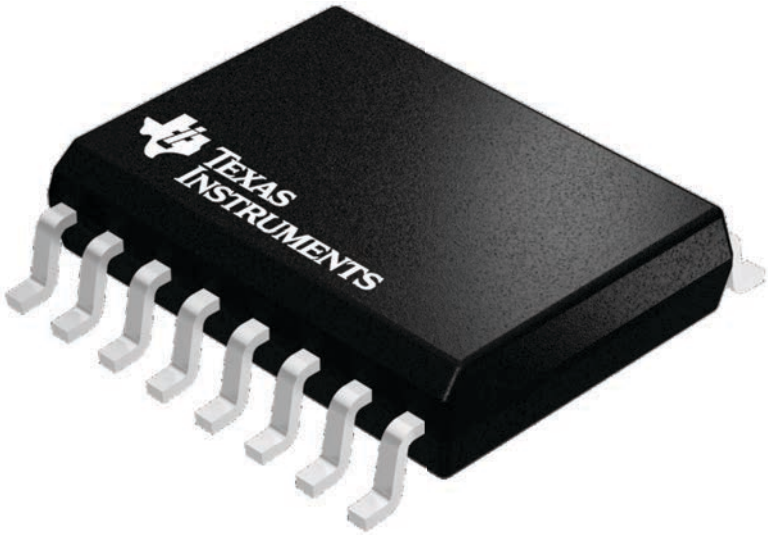
DW 16

SOIC - 2.65 mm max height

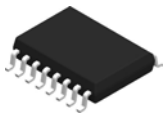
7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224780/A

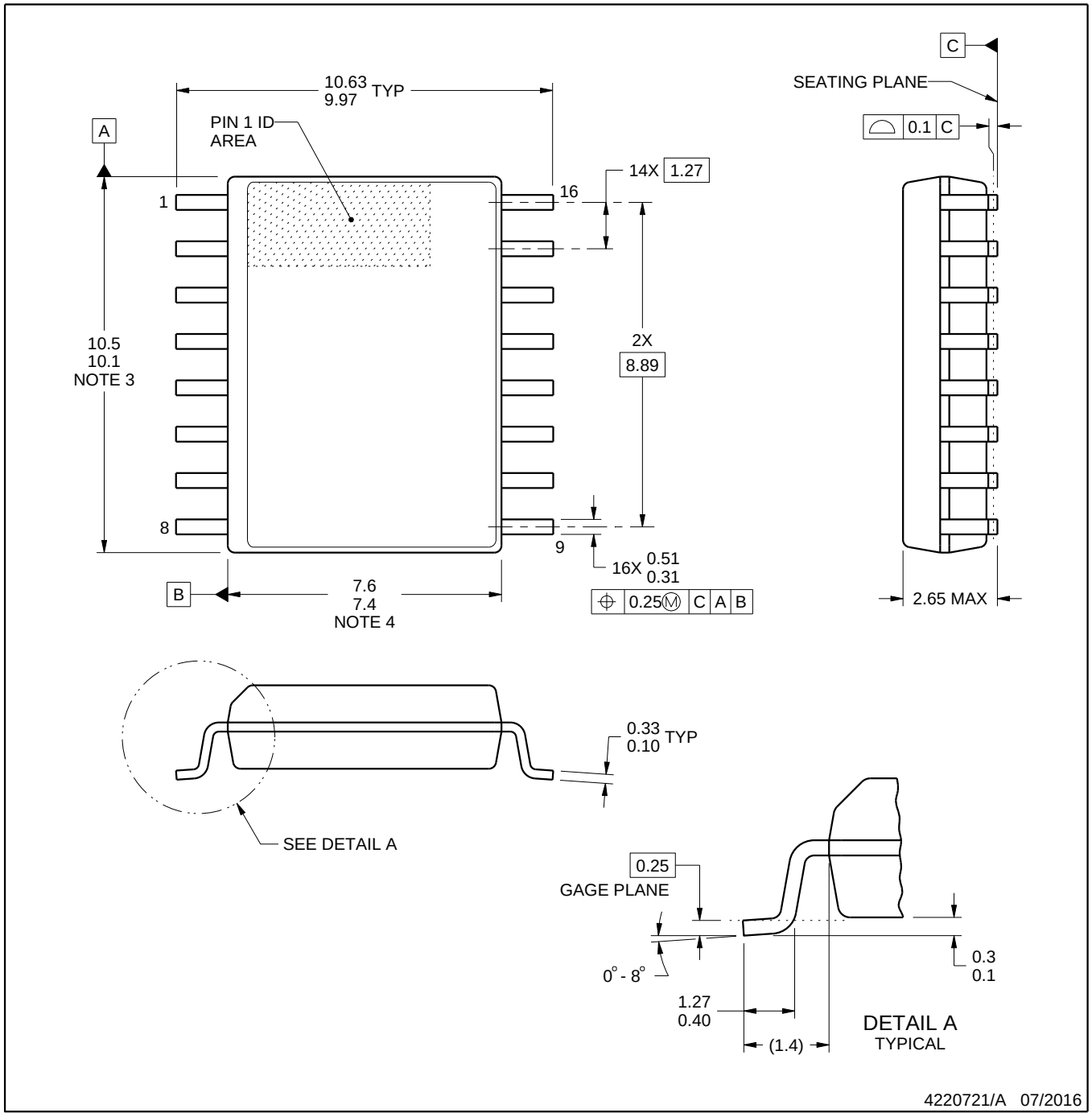


PACKAGE OUTLINE

DW0016A

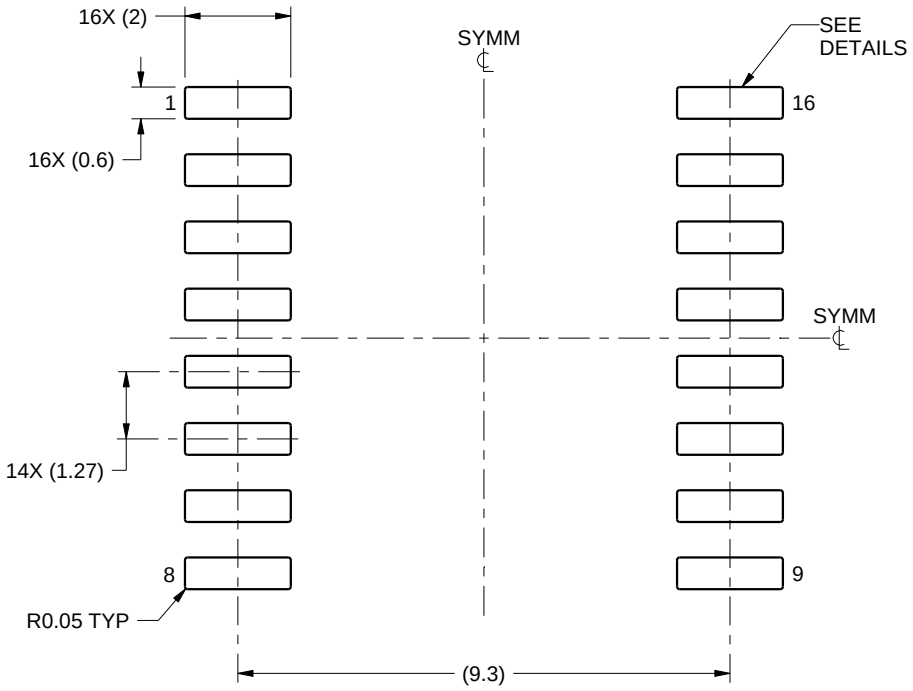
SOIC - 2.65 mm max height

SOIC

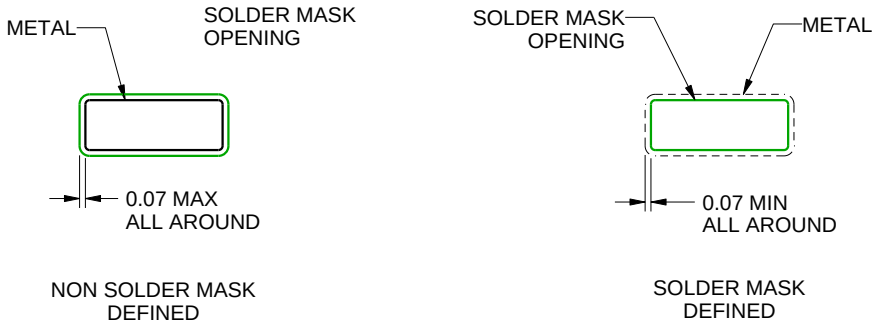


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.



LAND PATTERN EXAMPLE
SCALE:7X

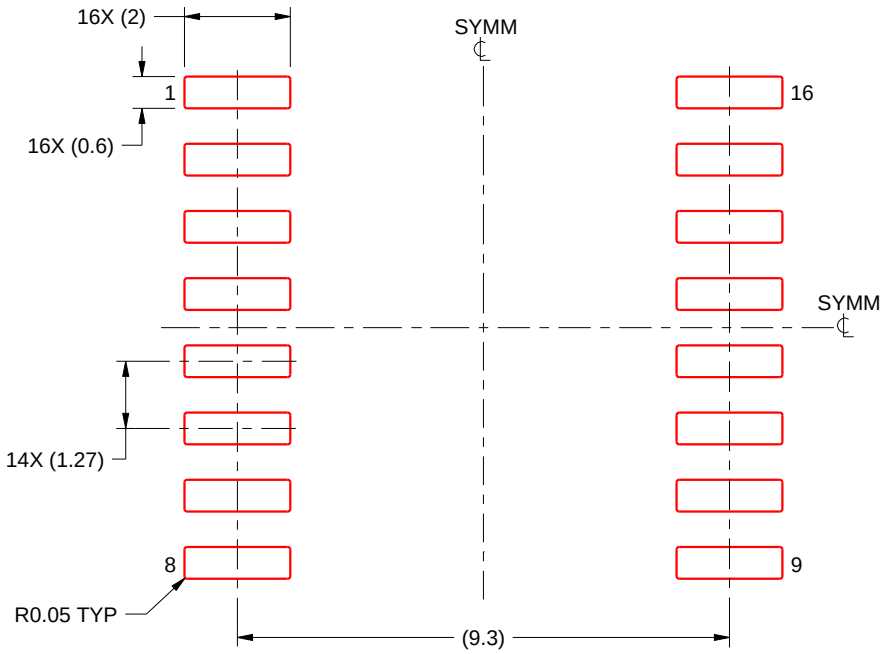


SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

4220721/A 07/2016

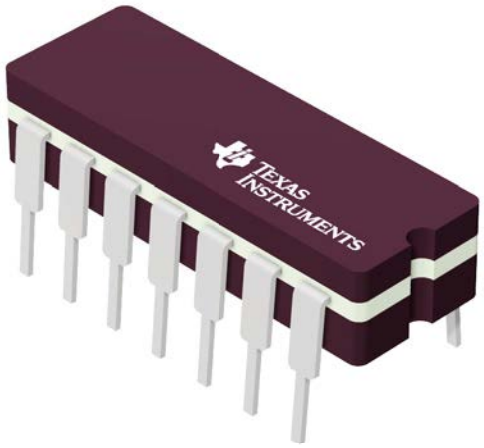
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

J 14 CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

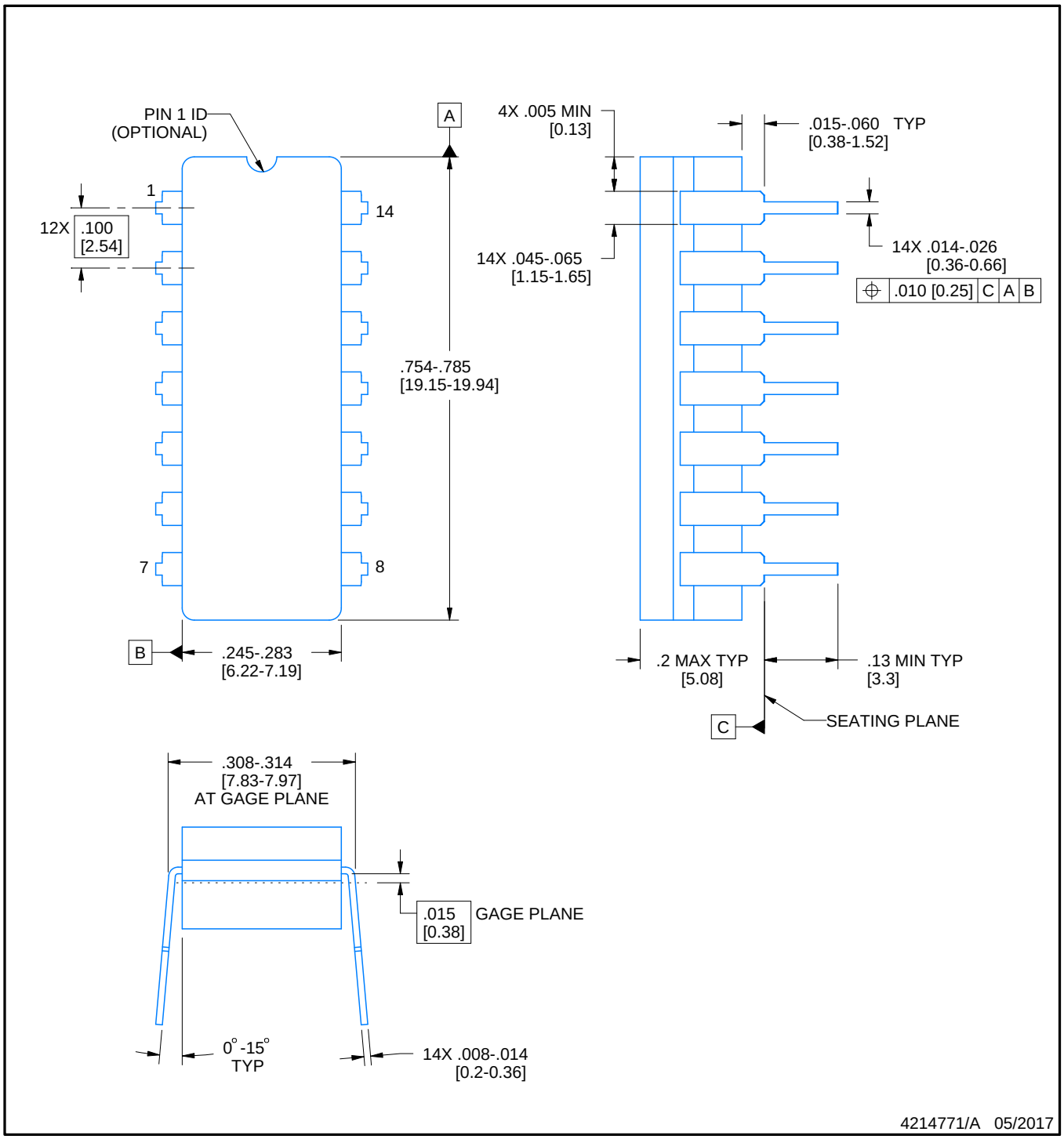
4040083-5/G

PACKAGE OUTLINE

J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



NOTES:

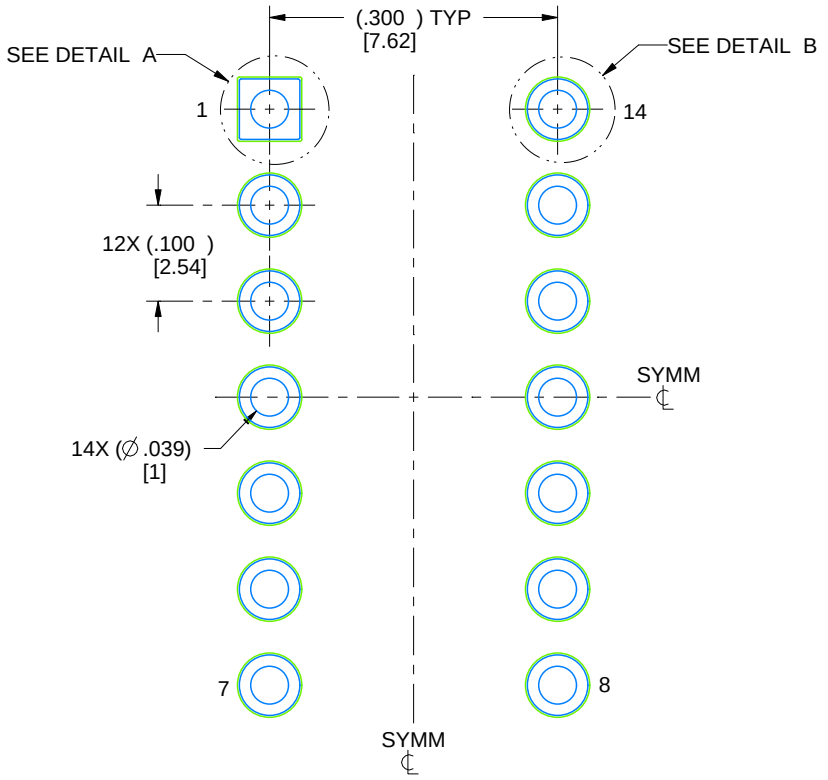
1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermitically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

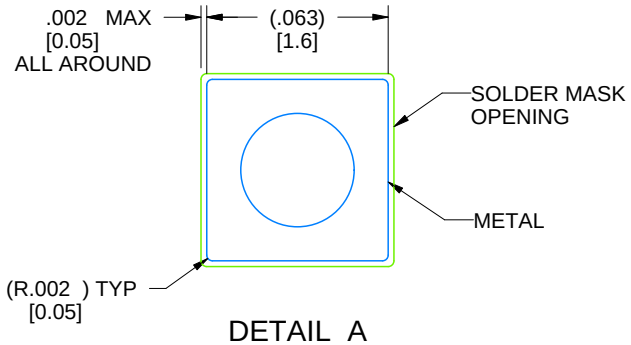
J0014A

CDIP - 5.08 mm max height

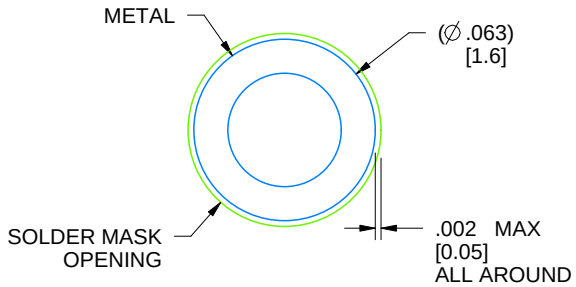
CERAMIC DUAL IN LINE PACKAGE



LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X

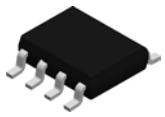


DETAIL A
SCALE: 15X



DETAIL B
13X, SCALE: 15X

4214771/A 05/2017

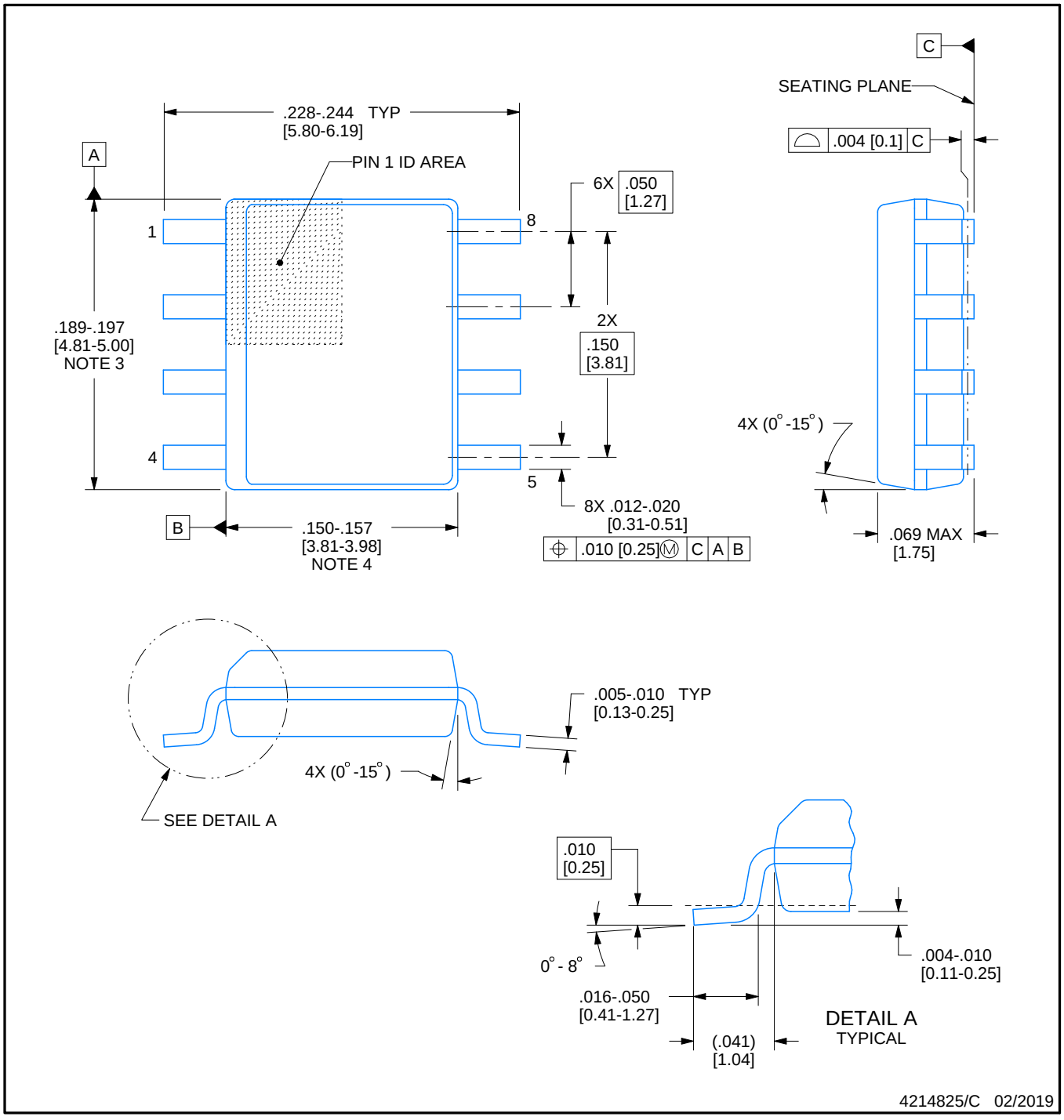


PACKAGE OUTLINE

D0008A

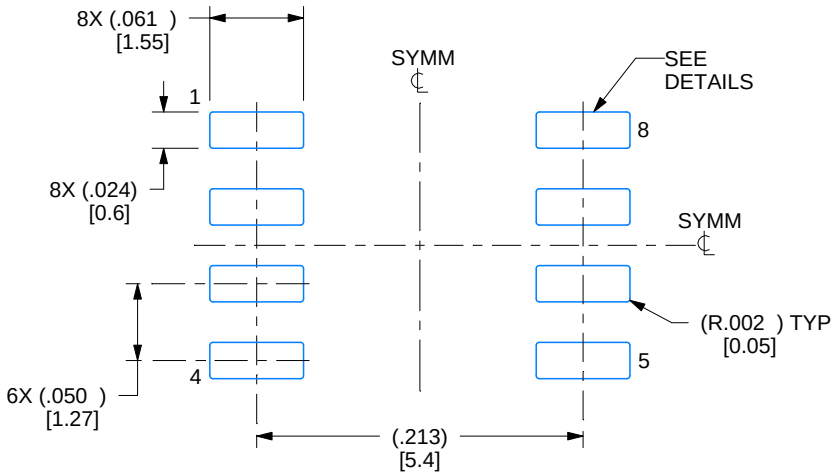
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

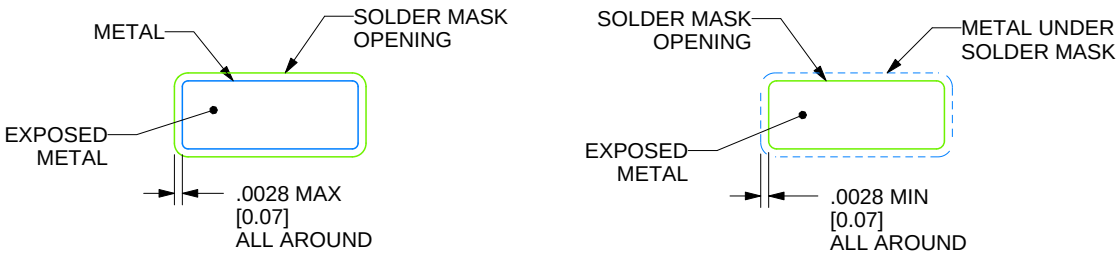


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

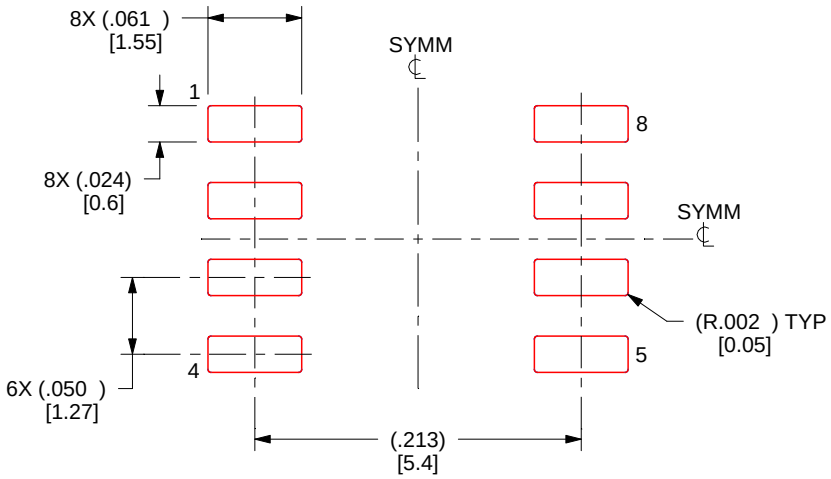
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

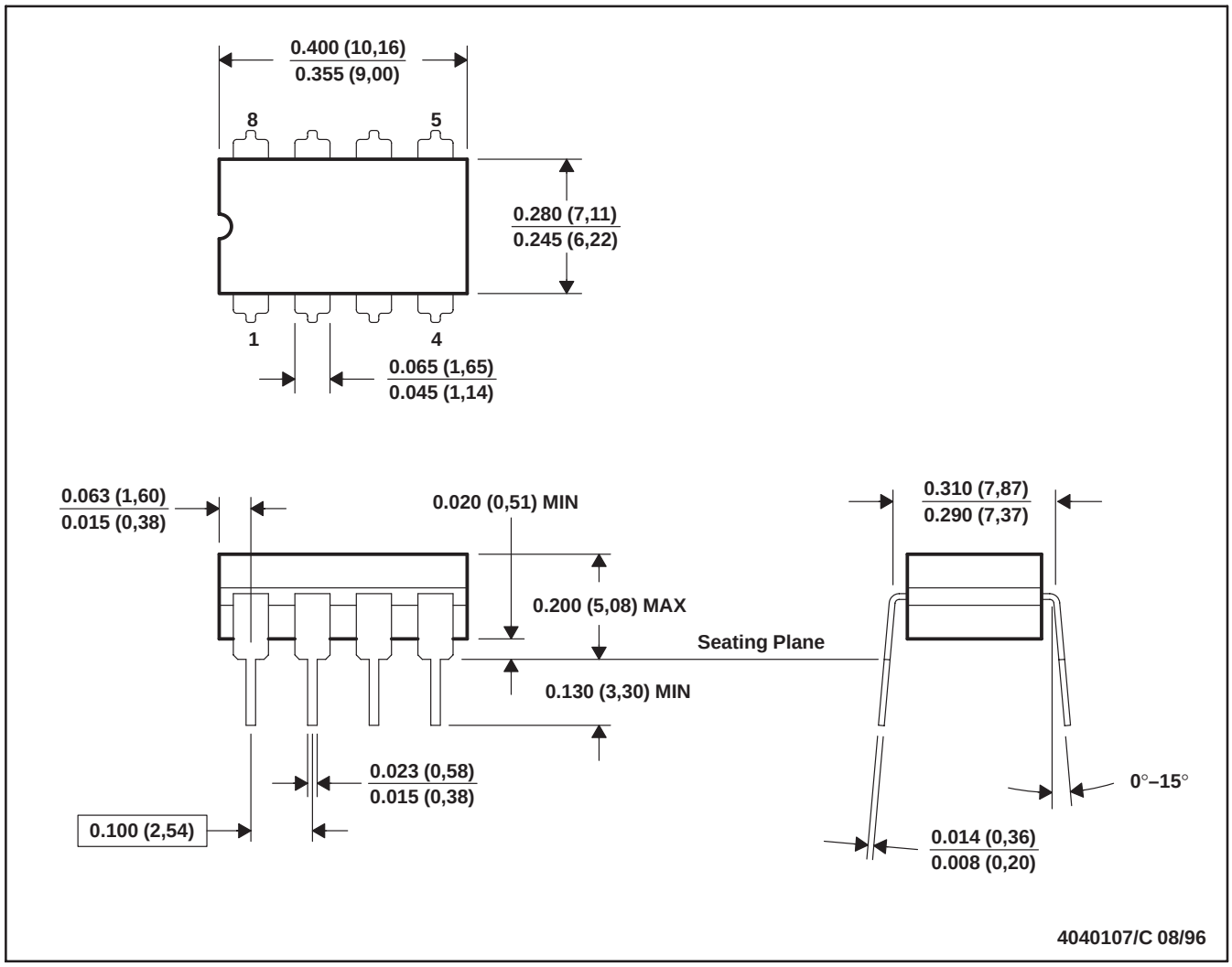
4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

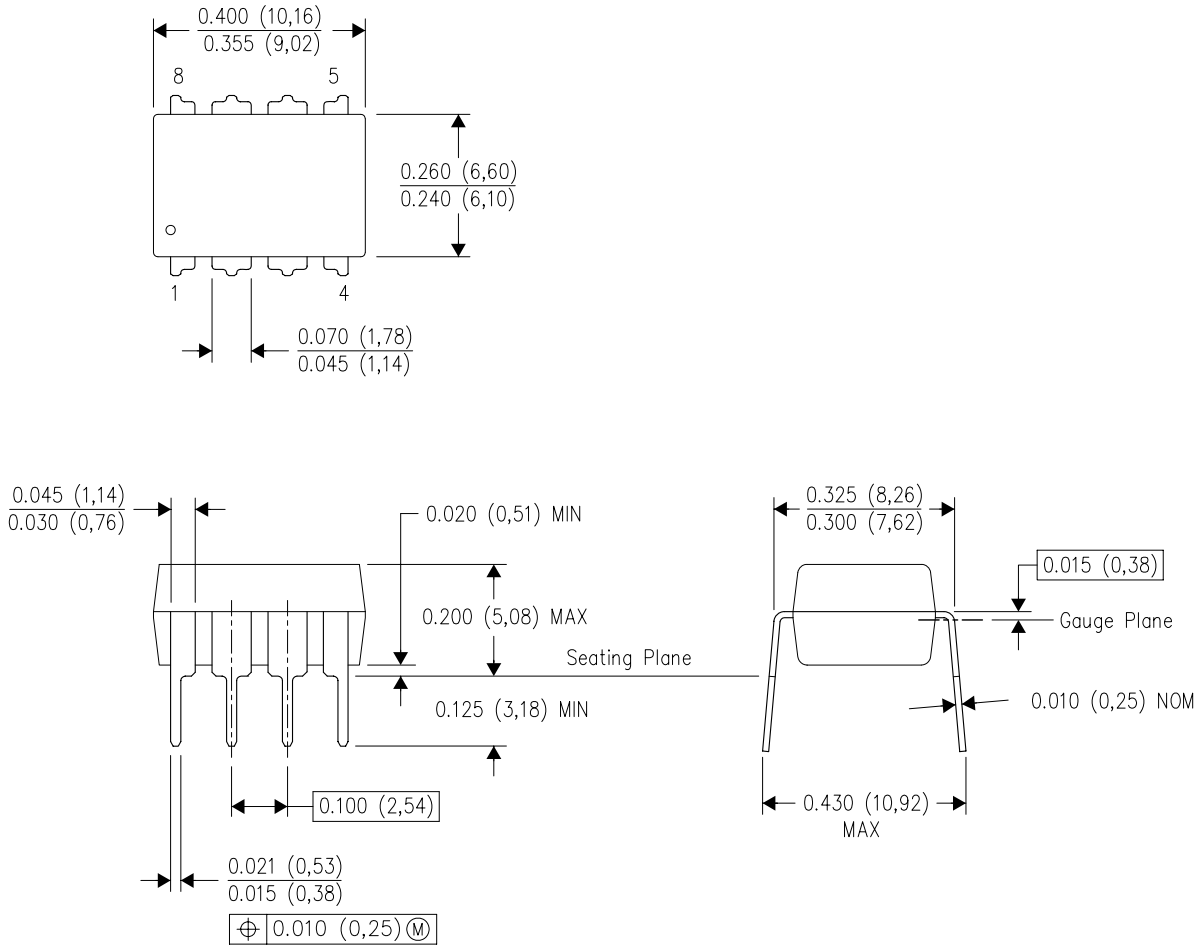
MCER001A – JANUARY 1995 – REVISED JANUARY 1997

JG (R-GDIP-T8) **CERAMIC DUAL-IN-LINE**



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification.
E. Falls within MIL STD 1835 GDIP1-T8

P (R–PDIP–T8) PLASTIC DUAL–IN–LINE PACKAGE

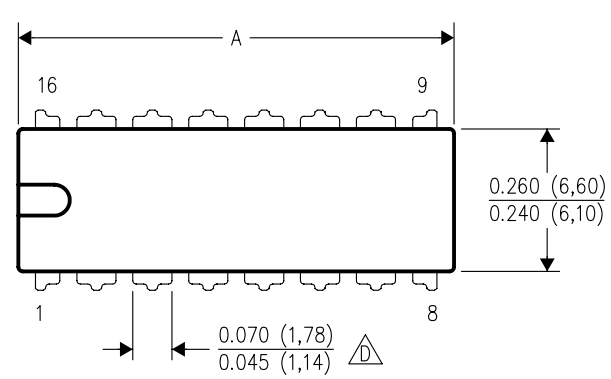


NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001 variation BA.

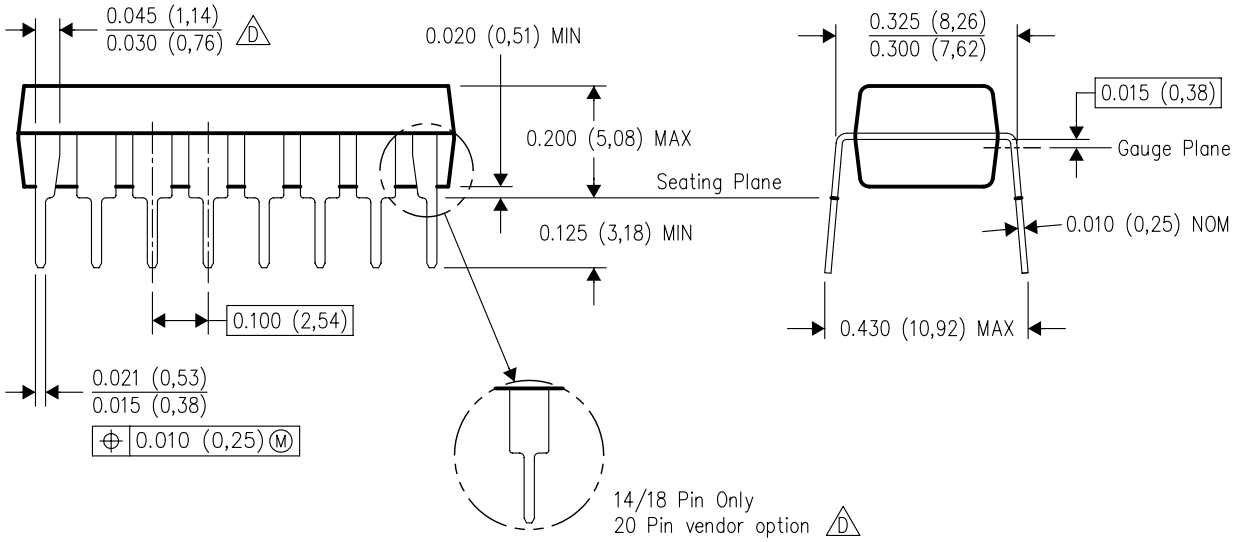
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN



DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



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NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

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